

CE EMC Test Report

Report No.: CE171206D25

Test Model: ARS-2000 Series

("X" can be 0-9, A-Z or blank for marketing purpose)

Received Date: Dec. 6, 2017

Test Date: Dec. 8, 2017 ~ Jan. 4, 2018

Issued Date: Jan. 9, 2018

Applicant: Vecow Co., Ltd.

Address: 12F., No. 111, Zhongcheng Rd., Tucheng Dist., New Taipei City 23674

Taiwan (R.O.C.)

Issued By: Bureau Veritas Consumer Products Services (H.K.) Ltd., Taoyuan Branch

Lab Address: No. 47-2, 14th Ling, Chia Pau Vil., Lin Kou Dist., New Taipei City, Taiwan

(R.O.C.)







Certificate #4327.01

This report is for your exclusive use. Any copying or replication of this report to or for any other person or entity, or use of our name or trademark, is permitted only with our prior written permission. This report sets forth our findings solely with respect to the test samples identified herein. The results set forth in this report are not indicative or representative of the quality or characteristics of the lot from which a test sample was taken or any similar or identical product specifically and expressly noted. Our report includes all of the tests requested by you and the results thereof based upon the information that you provided to us. You have 60 days from date of issuance of this report to notify us of any material error or omission caused by our negligence, provided, however, that such notice shall be in writing and shall specifically address the issue you wish to raise. A failure to raise such issue within the prescribed time shall constitute your unqualified acceptance of the completeness of this report, the tests conducted and the correctness of the report contents. Unless specific mention, the uncertainty of measurement has been explicitly taken into account to declare the compliance or non-compliance to the specification.

The report must not be used by the client to claim product certification, approval, or endorsement by A2LA or any agency of the federal government. The report must not be used by the client to claim product certification, approval, or endorsement by TAF or any government agencies.

Report No.: CE171206D25 Page No. 1 / 79 Report Format Version: 6.1.3



Table of Contents

Rei	ease Control Record	. 5
1	Certificate of Conformity	. 6
2	Summary of Test Results	. 7
2. 2.	,	
3	General Information	
3.	1 Features of EUT	9
3.	2 General Description of EUT	9
3.	1 0	
3. 3.	· · · · · · · · · · · · · · · · · · ·	
	Configuration and Connections with EUT	
4		
4. 4.		
5	Conducted Emission from the AC Mains Power Port	
5.		
5.		
5. 5.		
6	Asymmetric Mode Conducted Emission at Telecommunication Ports	
6.		
6.		
6. 6.		
	Radiated Emission at Frequencies up to 1GHz	
7		
7.	1 Limits	വ
_	O To at the attribute and a	
7. 7		28
7. 7. 7.	3 Test Arrangement	28 29
7. 7.	3 Test Arrangement	28 29 30
7. 7. 8	3 Test Arrangement	28 29 30 32
7. 7. 8 8.	Test Arrangement Test Results Radiated Emission at Frequencies above 1GHz	28 29 30 32 32
7. 7. 8 8. 8.	Test Arrangement Test Results Radiated Emission at Frequencies above 1GHz Limits Test Instruments	28 29 30 32 32 33
7. 7. 8 8.	Test Arrangement Test Results Radiated Emission at Frequencies above 1GHz Limits Test Instruments Test Arrangement	28 29 30 32 32 33 34
7. 7. 8 8. 8. 8.	Test Arrangement Test Results Radiated Emission at Frequencies above 1GHz Limits Test Instruments Test Arrangement	28 29 30 32 32 33 34 35
7. 7. 8 8. 8. 8. 8.	3 Test Arrangement 4 Test Results Radiated Emission at Frequencies above 1GHz 1 Limits 2 Test Instruments 3 Test Arrangement 4 Test Results Harmonics Current Measurement	28 29 30 32 32 33 34 35 37
7. 7. 8 8. 8. 8.	3 Test Arrangement	28 29 30 32 32 33 34 35 37
7. 7. 8 8. 8. 8. 8. 9	3 Test Arrangement	28 29 30 32 32 33 34 35 37 37
7. 7. 8 8. 8. 8. 8. 9 9. 9. 9. 9.	3 Test Arrangement 4 Test Results Radiated Emission at Frequencies above 1GHz 1 Limits 2 Test Instruments 3 Test Arrangement 4 Test Results Harmonics Current Measurement 1 Limits 2 Classification of Equipment 3 Test Instruments 4 Test Arrangement 5 Test Arrangement 7 Limits 8 Classification of Equipment 9 Test Arrangement	28 29 30 32 32 33 34 35 37 37 38 38
7. 7. 8 8. 8. 8. 9 9. 9.	3 Test Arrangement 4 Test Results Radiated Emission at Frequencies above 1GHz 1 Limits 2 Test Instruments 3 Test Arrangement 4 Test Results Harmonics Current Measurement 1 Limits 2 Classification of Equipment 3 Test Instruments 4 Test Arrangement 5 Test Arrangement 7 Limits 8 Classification of Equipment 9 Test Arrangement	28 29 30 32 32 33 34 35 37 37 38 38
7. 7. 8 8. 8. 8. 8. 9 9. 9. 9. 9.	3 Test Arrangement 4 Test Results Radiated Emission at Frequencies above 1GHz 1 Limits 2 Test Instruments 3 Test Arrangement 4 Test Results Harmonics Current Measurement 1 Limits 2 Classification of Equipment 3 Test Instruments 4 Test Arrangement 5 Test Arrangement 7 Limits 8 Classification of Equipment 9 Test Arrangement	28 29 30 32 32 33 34 35 37 37 38 38 39
7. 7. 8 8. 8. 8. 8. 9 9. 9. 9. 9. 10	3 Test Arrangement 4 Test Results Radiated Emission at Frequencies above 1GHz 1 Limits 2 Test Instruments 3 Test Arrangement 4 Test Results Harmonics Current Measurement 1 Limits 2 Classification of Equipment 3 Test Instruments 4 Test Arrangement 5 Test Results	28 29 30 32 32 33 34 35 37 37 38 38 39 40
7. 7. 8 8. 8. 8. 8. 9 9. 9. 9. 9. 10 10 10 10	Test Arrangement Test Results Radiated Emission at Frequencies above 1GHz Limits Test Instruments Test Arrangement Test Results Harmonics Current Measurement Limits Classification of Equipment Test Instruments Test Arrangement	28 29 30 32 32 33 34 35 37 37 38 38 39 40 40
7. 7. 7. 8 8. 8. 8. 8. 9 9. 9. 9. 9. 10 10 10 10 10 10 10 10 10 10 10 10 10	3 Test Arrangement 4 Test Results Radiated Emission at Frequencies above 1GHz	28 29 30 32 33 34 35 37 37 38 38 39 40 40 40



11	Gene	eral Immunity Requirements	42
11.	.1	Performance Criteria	.43
12	Elec	trostatic Discharge Immunity Test (ESD)	44
12	.1	Test Specification	.44
12		Test Instruments	
12		Test Arrangement	
12	.4	Test Results	46
13	Radi	ated, Radio-frequency, Electromagnetic Field Immunity Test (RS)	50
13	.1	Test Specification	.50
13		Test Instruments	
13		Test Arrangement	
13	.4	Test Results	.52
14	Elec	trical Fast Transient/Burst Immunity Test (EFT)	53
14	.1	Test Specification	.53
14	.2	Test Instruments	.53
14		Test Arrangement	
14	.4	Test Results	.55
15	Surg	e Immunity Test	56
15	.1	Test Specification	.56
15	.2	Test Instruments	.56
15		Test Arrangement	
15	.4	Test Results	.58
16	lmm	unity to Conducted Disturbances Induced by RF Fields (CS)	59
16	.1	Test Specification	.59
16		Test Instruments	60
16		Test Arrangement	
16	.4	Test Results	.62
17	Pow	er Frequency Magnetic Field Immunity Test	63
17		Test Specification	
17		Test Instruments	
17		Test Arrangement	
17	.4	Test Results	.64
18		ge Dips and Interruptions	
18		Test Specification	
18		Test Instruments	
18		Test Arrangement	
18		Test Results	
19		ures of Test Arrangements	
19		Conducted Emission from the AC Mains Power Port	
19	.2	Asymmetric Mode Conducted Emission at Telecommunication Ports	.68
19		Radiated Emission at Frequencies up to 1GHz	
19		Radiated Emission at Frequencies above 1GHz	
19		Harmonics Current, Voltage Fluctuations and Flicker Measurement	
19 19		Electrostatic Discharge Immunity Test (ESD)	
19		Electrical Fast Transient/Burst Immunity Test (EFT)	
19		Surge Immunity Test	
		Conducted Disturbances Induced by RF Fields (CS)	
		Power Frequency Magnetic Field Immunity Test (PFMF)	
-		. , ,	



19.12 Voltage Dips and Interruptions78	}
Appendix – Information on the Testing Laboratories	



Release Control Record

Issue No.	Description	Date Issued
CE171206D25	Original release.	Jan. 9, 2018



1 Certificate of Conformity

Product: ARS-2000

Brand: Vecow

Test Model: ARS-2000 Series

Series Model: ARS-2XXXXXXXXXXXXXXXX

("X" can be 0-9, A-Z or blank for marketing purpose)

Sample Status: Engineering sample

Applicant: Vecow Co., Ltd.

Test Date: Dec. 8, 2017 ~ Jan. 4, 2018

Standards: EN 55032:2015 +AC:2016, Class A

EN 61000-3-2:2014 EN 61000-3-3:2013 EN 55024:2010

EN 61000-4-2:2009 / IEC 61000-4-2:2008 ED. 2.0

EN 61000-4-3:2006 +A1:2008 +A2:2010 / IEC 61000-4-3:2010 ED. 3.2

EN 61000-4-4:2012 / IEC 61000-4-4:2012 ED. 3.0 EN 61000-4-5:2014 / IEC 61000-4-5:2014 ED. 3.0 EN 61000-4-6:2014 / IEC 61000-4-6:2013 ED. 4.0 EN 61000-4-8:2010 / IEC 61000-4-8:2009 ED. 2.0 EN 61000-4-11:2004 / IEC 61000-4-11:2004 ED. 2.0

The above equipment has been tested by **Bureau Veritas Consumer Products Services (H.K.) Ltd., Taoyuan Branch**, and found compliance with the requirement of the above standards. The test record, data evaluation & Equipment Under Test (EUT) configurations represented herein are true and accurate accounts of the measurements of the sample's EMC characteristics under the conditions specified in this report.

Jessica Cheng / Senior Specialist

Approved by: , Date: Jan. 9, 2018

Henry Lal / Director



2 Summary of Test Results

Emission						
Standard	Test Item	Result/Remarks	Verdict			
	Conducted emission from the AC mains power port	Minimum passing Class A margin is -15.61 dB at 0.15781 MHz	Pass			
EN 55032:2015 +AC:2016	Asymmetric mode conducted emission at telecommunication ports	Minimum passing Class A margin is -0.88 dB at 0.40781 MHz	Pass			
	Radiated emission 30-1000 MHz	Minimum passing Class A margin is -0.54 dB at 999.99 MHz	Pass			
	Radiated emission above 1GHz	Minimum passing Class A margin is -3.74 dB at 1233.25 MHz	Pass			
EN 61000-3-2:2014	Harmonic current emissions	The power consumption of EUT is less than 75W and no limits apply	Pass			
EN 61000-3-3:2013	Voltage fluctuations and flicker	$\begin{array}{ll} P_{st} \leq 1.0 & d_{max} \leq 4\% \\ P_{lt} \leq 0.65 & d_c \leq 3.3\% \\ T_{max} \leq 500ms \end{array}$	Pass			

Immunity					
EN 55024 Clause	Basic standard	Test Item	Result/Remarks	Verdict	
4.2.1	EN 61000-4-2:2009 / IEC 61000-4-2:2008 ED. 2.0	Electrostatic discharges (ESD)	Performance Criterion B	Pass	
4.2.3.2	EN 61000-4-3:2006 +A1:2008 +A2:2010 / IEC 61000-4-3:2010 ED. 3.2	Continuous radiated disturbances (RS)	Performance Criterion A	Pass	
4.2.2	EN 61000-4-4:2012 / IEC 61000-4-4:2012 ED. 3.0	Electrical fast transients (EFT)	Performance Criterion A	Pass	
4.2.5	EN 61000-4-5:2014 / IEC 61000-4-5:2014 ED. 3.0	Surges	Performance Criterion B	Pass	
4.2.3.3	EN 61000-4-6:2014 / IEC 61000-4-6:2013 ED. 4.0	Continuous conducted disturbances (CS)	Performance Criterion A	Pass	
4.2.4	EN 61000-4-8:2010 / IEC 61000-4-8:2009 ED. 2.0	Power-frequency magnetic fields (PFMF)	Performance Criterion A	Pass	
EN 61000-4-11:2004 / IEC 61000-4-11:2004 ED. 2.0		Voltage dips and interruptions	Voltage Dips: >95% reduction – 0.5 period, Performance Criterion A 30% reduction – 25 periods, Performance Criterion A Voltage Interruptions: >95% reduction – 250 periods, Performance Criterion C	Pass	

Note:

- 1. There is no deviation to the applied test methods and requirements covered by the scope of this report.
- 2. The above EN/IEC basic standards are applied with latest version if customer has no special requirement.



2.1 Measurement Uncertainty

Where relevant, the following measurement uncertainty levels have been estimated for tests performed on the EUT as specified in CISPR 16-4-2:

The listed uncertainties are the worst case uncertainty for the entire range of measurement. Please note that the uncertainty values are provided for informational purposes only and are not used in determining the PASS/FAIL results.

Measurement	Expended Uncertainty (k=2) (±)	Maximum allowable uncertainty (±)
Conducted emission from AC mains power port using AMN, 150kHz ~ 30MHz	2.77 dB	3.4 dB (<i>U</i> _{cispr})
Asymmetric mode conducted emission using AAN, 150kHz ~ 30MHz	3.94 dB	5.0 dB (<i>U</i> _{cispr})
Radiated emission, 30MHz ~ 1GHz	3.89 dB	6.3 dB (<i>U</i> _{cispr})
Radiated emission, 1GHz ~ 6GHz	4.97 dB	5.2 dB (<i>U</i> _{cispr})

2.2 Modification Record

There were no modifications required for compliance.



3 General Information

3.1 Features of EUT

The tests reported herein were performed according to the method specified by Vecow Co., Ltd., for detailed feature description, please refer to the manufacturer's specifications or user's manual.

3.2 General Description of EUT

Product	ARS-2000
Brand	Vecow
Test Model	ARS-2000 Series
Corios Madal	ARS-2XXXXXXXXXXXXXX
Series Model	("X" can be 0-9, A-Z or blank for marketing purpose)
Model Difference	For marketing purpose
Sample Status	Engineering sample
Operating Software	Windows 10, Windows 8.1, Windows 7, Linux
Power Supply Rating	6V to 36V, DC-in
Accessory Device	Adapter
Data Cable Supplied	N/A

Note:

- 1. The EUT is an Embedded Box PC with the following interfaces.
 - ♦ DC input
 - ♦ USB 3.0*4

 - ♦ POE LAN*2
 - ♦ DVI-D (resolution Up to 1920 x 1200 @ 60Hz)
 - ♦ DVI-I (resolution Up to 1920 x 1200 @ 60Hz)
 - ♦ Mic. in
 - ♦ Line out
 - ♦ Isolated DIO*2 (32 Isolated DIO : 16 DI, 16 DO)
 - ♦ CFast socket
 - ♦ COM*4 (RS-232/ 422/ 485)





2. The EUT was configured with the following key components:

System

Processor Intel® Core™ i7/i5/i3 U-series Processor

(Kaby Lake-U/Skylake-U)

 Chipset
 Intel® SoC

 BIOS
 AMI

 SIO
 IT8786E

Memory
OS
2 DDR4 2133MHz SO-DIMM, up to 32GB
Windows 10, Windows 8.1, Windows 7, Linux
(Windows 8.1 & 7 are not available for Kaby Lake)

Storage

SATA 2 SATA III support S/W RAID 0, 1:

1 SATA III (6Gbps)

1 SATA III co-lay with Mini PCIe (6Gbps)

mSATA 1 SATA III co-lay with SATA (Mini PCIe Type, 6Gbps)
Storage Device 1 CFast Socket, Push-in/Push-out Ejector

• 2 2.5" SSD/HDD Bracket (Internal)



3. The EUT uses following adapter.

Brand	MEAN WELL
Model	GS160A24
Input Power	100-240Vac, 50/60Hz, 2.0A
Output Power	24V, 6.67A, 160W max.
Power Line	Non-shielded DC (1.15m) with one ferrite core

3.3 Operating Modes of EUT and Determination of Worst Case Operating Mode

- 1. The EUT was pre-tested under operating and standby condition and the worst emission level was found under **operating condition**.
- 2. The EUT consumed DC power from AC adapter, which designed with AC power supply of 100-240Vac, 50/60Hz.

For radiated emission evaluation, 230Vac/50Hz & 110Vac/60Hz had been covered during the pre-test. The worst data was found at **110Vac/60Hz** and recorded in the applied test report.

3. Test modes are presented in the report as below.

Mode	Test Condition	Input Power				
	Conducted emission test					
1	1 Full system, DVI & D-Sub: 1920x1080, 60Hz 230Vac/ 50Hz & 110Vac/ 60Hz (Adapter)					
	Asymmetric mode conducted emission at telecommunica	ation ports test				
1	1 Full system, DVI & D-Sub: 1920x1080, 60Hz, LAN port 1 (1Gbps)					
2 Full system, DVI & D-Sub: 1920x1080, 60Hz, PoE LAN port 2 23		230Vac/ 50Hz (Adapter)				
3 Full system, DVI & D-Sub: 1920x1080, 60Hz, PoE LAN port 3						

The idle mode of conducted emission test at telecom port was pre-tested based on the worst case of link mode. Due to emissions of idle mode being very low compared to link mode, only the link mode data were presented in the test report.

Radiated emission							
1	1 Full system, DVI & D-Sub: 1920x1080, 60Hz 110Vac/ 60Hz (Adapter)						
	Harmonics, Flicker & Immunity tests						
1	1 Full system, DVI & D-Sub: 1920x1080, 60Hz 230Vac/ 50Hz (Adapter)						



3.4 Test Program Used and Operation Descriptions

Emission tests:

- a. Turned on the power of all equipment.
- b. EUT ran a test program to enable all functions.
- c. EUT read and wrote messages from/to card reader, SSD and ext. HDDs.
- d. EUT sent and received messages to/from Notebook PC (kept in a remote area) via one UTP LAN cable.
- e. EUT sent "color bars with moving element" messages to ext. LCD Monitors. Then they displayed "color bars" messages on their screens simultaneously.
- f. EUT sent 1kHz audio signal to earphone.
- g. EUT sent messages to printer and printer printed them out.
- h. Cameras captured video image to LCD Monitors via EUT.
- i. Steps c-i were repeated.

Harmonics, Flicker & Immunity tests:

- a. Turned on the power of all equipment.
- b. EUT ran a test program to enable all functions.
- c. EUT read and wrote messages from/to SSD and ext. USB flash.
- j. EUT sent and received messages to/from Notebook PC (kept in a remote area) via one UTP LAN cable.
- d. EUT sent and received messages to/from Notebook PC (kept in a remote area) via one STP LAN cable. (For CS & RS test only)
- e. EUT sent "H" messages to ext. LCD Monitors. Then they displayed "H" messages on their screens simultaneously.
- f. EUT sent 1kHz audio signal to speaker.
- g. Cameras captured video image to LCD Monitors via EUT.
- h. Steps c-g were repeated.

3.5 Primary Clock Frequencies of Internal Source

The highest frequency generated or used within the EUT or on which the EUT operates or tunes is 4000 MHz, provided by Vecow Co., Ltd., for detailed internal source, please refer to the manufacturer's specifications.

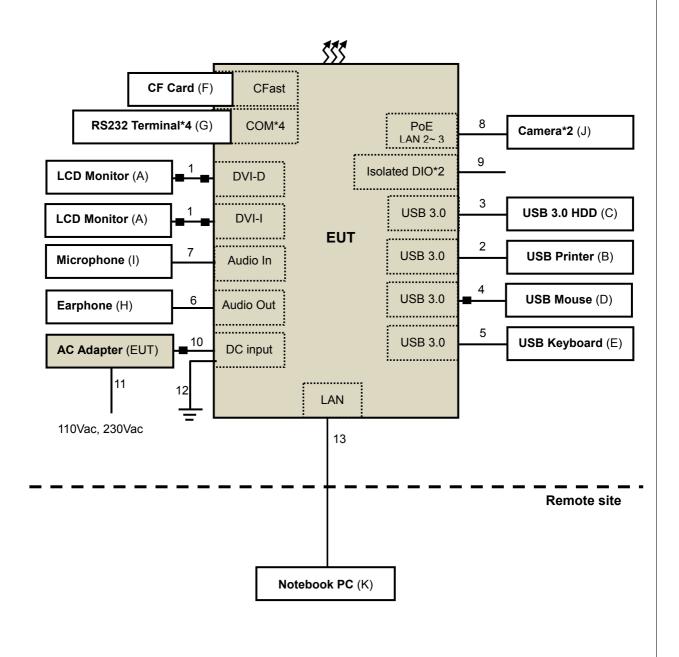


4 Configuration and Connections with EUT

4.1 Connection Diagram of EUT and Peripheral Devices

Emission tests:

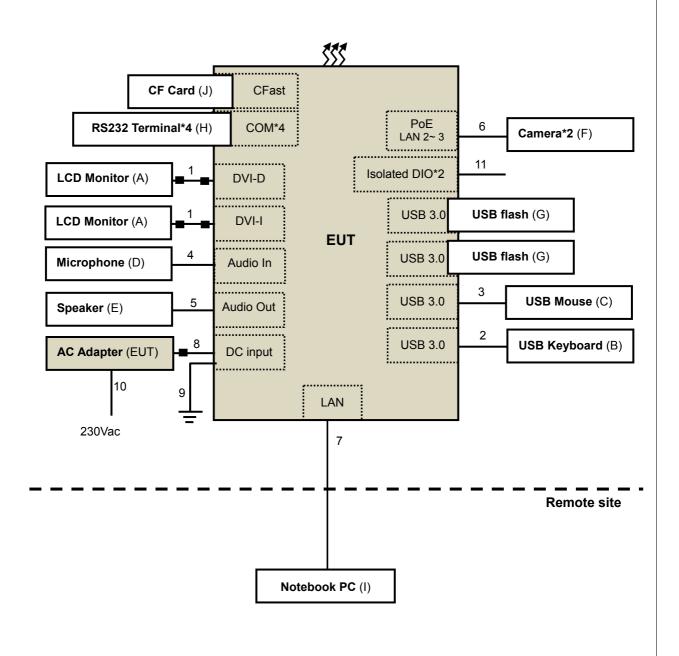
TEST CONFIGURATION





Harmonics, Flicker & Immunity tests:

TEST CONFIGURATION





4.2 Configuration of Peripheral Devices and Cable Connections

Emission tests:

ID	Product	Brand	Model No.	Serial No.	FCC ID	Remarks
	24" LCD MONITOR	DELL	U2410	CN082WXD728720CC 0L2L	FCC DoC Approved	Provided by Lab
Α.	24" LCD MONITOR	DELL	U2410	CN082WXD728720CC 0KCL	FCC DoC Approved	Provided by Lab
B.	PRINTER	HP	HP Officejet Pro 251dw	N/A	N/A	Provided by Lab
C.	USB 3.0 Hard Disk	WD	WDBUZG0010BBK-PESN	WX61A45JR2YK	FCC DoC Approved	Provided by Lab
D.	USB Mouse	Microsoft	1113	9170515772199	FCC DoC Approved	Provided by Lab
E.	USB Keyboard	BTC	5200U	G09302046623	E5XKB5122U	Provided by Lab
F.	CF Card	INNODISK	CFast 3ME	S0011505080100003	N/A	Supplied by client
G.	RS232 Terminal *4	N/A	N/A	N/A	N/A	Supplied by client
H.	EARPHONE	PHILIPS	SBC HL145	N/A	N/A	Provided by Lab
I.	MICROPHONE	Labtec	mic-333	N/A	N/A	Provided by Lab
	2M Fixed Mini Indoor					
J.	Dome Network	N/A	A200MIF-HNG-03	N/A	N/A	Supplied by client
	Camera					
K.	Notebook PC	ASUS	PU401L	E9NXBC002007372	N/A	Provided by Lab

Note:

- 1. All power cords of the above support units are non-shielded (1.8m).
- 2. Items K acted as communication partners to transfer data.

ID	Descriptions	Qty.	Length (m)	Shielding (Yes/No)	Cores (Qty.)	Remarks
1.	DVI cable	2	1.8	Y	2	Provided by Lab
2.	USB cable	1	1.5	Υ	0	Provided by Lab
3.	USB cable	1	0.5	Υ	0	Provided by Lab
4.	USB cable	1	1.8	Y	1	Provided by Lab
5.	USB cable	1	1.5	Υ	0	Provided by Lab
6.	Audio cable	1	1.2	N	0	Provided by Lab
7.	Audio cable	1	2.4	N	0	Provided by Lab
8.	LAN cable (Cat. 5e)	2	3.0	N	0	Provided by Lab
9.	cable	2	0.5	N	0	Supplied by client
10.	DC cable	1	1.15	N	1	Supplied by client
11.	AC power cord	1	1.8	N	0	Provided by Lab
12.	GND cable	1	1.2	N	0	Provided by Lab
13.	LAN cable (Cat. 5e)	1	10	N	0	Provided by Lab

Note: The core(s) is(are) originally attached to the cable(s).



Harmonics, Flicker, Immunity tests:

ID	Product	Brand	Model No.	Serial No.	FCC ID	Remarks
	LCD MONITOR DELL		2408WFP	CN0NN792742618231 3CS	FCC DoC Approved	Provided by Lab
Α.	24" LCD MONITOR	DELL	U2410	CN082WXD728720CC 0KDL	FCC DoC Approved	Provided by Lab
B.	USB Keyboard	HP	SK-2085	N/A	N/A	Provided by Lab
C.	MOUSE	HP	M-UAE96	F93A90AN3V42GO7	FCC DoC Approved	Provided by Lab
D.	MICROPHONE	N/A	N/A	N/A	N/A	Provided by Lab
E.	Speaker	N/A	N/A	N/A	N/A	Provided by Lab
F.	2M Fixed Mini Indoor Dome Network Camera	N/A	A200MIF-HNG-03	N/A	N/A	Supplied by client
G.	USB flash *2	hp	N/A	N/A	N/A	Provided by Lab
Н.	RS232 Terminal *4	N/A	N/A	N/A	N/A	Supplied by client
I.	Notebook PC	LENOVO	TP00057A	R9-0JMLFS16/01	N/A	Provided by Lab
J.	CF Card	INNODISK	CFast 3ME	S0011505080100003	N/A	Supplied by client

Note:

- 1. All power cords of the above support units are non-shielded (1.8m).
- 2. Items I acted as communication partners to transfer data.

ID	Descriptions	Qty.	Length (m)	Shielding (Yes/No)	Cores (Qty.)	Remarks
1.	DVI cable	2	1.8	Y	2	Provided by Lab
2.	USB cable	1	1.5	Y	0	Provided by Lab
3.	USB cable	1	1.2	Y	0	Provided by Lab
4.	Audio cable	1	0.8	N	0	Provided by Lab
5.	Audio cable	1	1.0	N	0	Provided by Lab
6.	LAN cable (Cat. 5e)	2	5.0	N	0	Provided by Lab
	LAN cable (Cat. 5e)	1	5	N	0	Provided by Lab RS & CS test excluded
7.	LAN cable (Cat. 5e)	1	5	Y	0	Provided by Lab For RS & CS test only
8.	DC cable	1	1.15	N	1	Supplied by client
9.	GND cable	1	1.8	N	0	Provided by Lab
10.	AC power cord	1	1.8	N	0	Provided by Lab
11.	cable	2	0.5	N	0	Supplied by client

Note: The core(s) is(are) originally attached to the cable(s).



5 Conducted Emission from the AC Mains Power Port

5.1 Limits

Frequency range (MHz)	Coupling device	Detector type / bandwidth	Class A limits (dBuV)
0.15 - 0.5		Ougoi poak / 0kHz	79
0.5 - 30.0	AMNI	Quasi-peak / 9kHz	73
0.15 - 0.5	AMN	Average / 9kHz	66
0.5 - 30.0		Average / 9KHZ	60

Frequency range (MHz)	Coupling device	Detector type / bandwidth	Class B limits (dBuV)
0.15 - 0.5			66 - 56
0.5 - 5		Quasi-peak / 9kHz	56
5 - 30.0	A B 48 I		60
0.15 - 0.5	AMN		56 - 46
0.5 - 5		Average / 9kHz	46
5 - 30.0			50

5.2 Test Instruments

Description & Manufacturer	Model No.	Serial No.	Cal. Date	Cal. Due
ROHDE & SCHWARZ TEST RECEIVER	ESCS 30	838251/021	Nov. 1, 2017	Oct. 31, 2018
ROHDE & SCHWARZ Artificial Mains Network (For EUT)	ENV216	101195	May 2, 2017	May 1, 2018
LISN With Adapter (for EUT)	AD10	C03Ada-002	May 2, 2017	May 1, 2018
EMCO L.I.S.N. (For peripherals)	3825/2	9504-2359	Jul. 25, 2017	Jul. 24, 2018
SCHWARZBECK Artificial Mains Network (For EUT)	NNLK8129	8129229	May 9, 2017	May 8, 2018
Software	Cond_V7.3.7.4	NA	NA	NA
RF cable (JYEBAO) With10dB PAD	5D-FB	Cable-C03-01	Sep. 19, 2017	Sep. 18, 2018
LYNICS Terminator (For EMCO LISN)	0900510	E1-01-300	Jan. 18, 2017	Jan. 17, 2018
LYNICS Terminator (For EMCO LISN)	0900510	E1-01-301	Jan. 18, 2017	Jan. 17, 2018
ROHDE & SCHWARZ Artificial Mains Network (For TV EUT)	ESH3-Z5	100220	Nov. 14, 2017	Nov. 13, 2018
LISN With Adapter (for TV EUT)	100220	N/A	Nov. 14, 2017	Nov. 13, 2018

Notes: 1. The calibration interval of the above test instruments is 12 months and the calibrations are traceable to NML/ROC and NIST/USA.

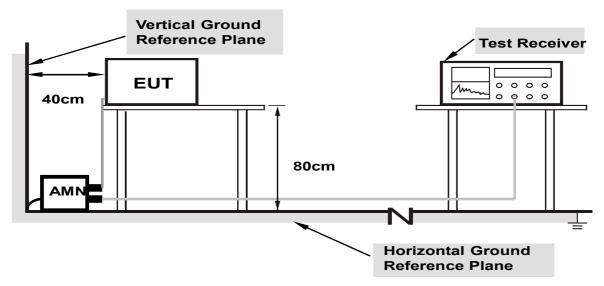
- 2. The test was performed in Shielded Room No. 3.
- 3. The VCCI Site Registration No. C-10274.
- 4. Tested Date: Dec. 11, 2017



5.3 Test Arrangement

- a. The EUT was placed 0.4 meters from the conducting wall of the shielded room with EUT being connected to the power mains through an Artificial Mains Network (AMN). Other support units were connected to the power mains through another AMN. The two AMNs provide 50 Ohm/ 50uH of coupling impedance for the measuring instrument.
- b. Both lines of the power mains connected to the EUT were checked for maximum conducted interference.
- c. The test results of conducted emissions at mains ports are recorded of six worst margins for quasi-peak (mandatory) [and average (if necessary)] values against the limits at frequencies of interest unless the margin is 20 dB or greater.

Note: The resolution bandwidth and video bandwidth of test receiver is 9kHz for quasi-peak detection (QP) and average detection (AV) at frequency 0.15MHz-30MHz.



Note: 1. Support units were connected to second AMN.

- 2. The distance specified between EUT/AE and other metallic objects is ≥ 0.8 m in the measurement arrangement for table-top EUT.
- 3. Cable on the RGP must to be insulated.

For the actual test configuration, please refer to the related item – Photographs of the Test Configuration.

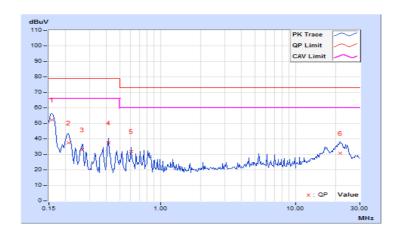


5.4 Test Results

Frequency Range	150kHz ~ 30MHz	Detector Function & Bandwidth	Quasi-Peak (QP) / Average (AV), 9kHz
Input Power	110Vac, 60Hz (Adapter)	Environmental Conditions	22℃, 65%RH, 1011mbar
Tested by	Chin-Wen Wang		
Test Mode	Mode 1		

	Phase Of Power : Line (L)									
No	Frequency	Correction Factor	Reading Value (dBuV)		Emission Level (dBuV)		Limit (dBuV)		Margin (dB)	
	(MHz)	(dB)	Q.P.	AV.	Q.P.	AV.	Q.P.	AV.	Q.P.	AV.
1	0.15781	9.57	42.81	38.33	52.38	47.90	79.00	66.00	-26.62	-18.10
2	0.20859	9.58	27.96	14.23	37.54	23.81	79.00	66.00	-41.46	-42.19
3	0.26328	9.58	23.54	20.49	33.12	30.07	79.00	66.00	-45.88	-35.93
4	0.41172	9.58	27.84	27.57	37.42	37.15	79.00	66.00	-41.58	-28.85
5	0.60703	9.59	22.41	22.39	32.00	31.98	73.00	60.00	-41.00	-28.02
6	21.60547	9.90	20.87	13.47	30.77	23.37	73.00	60.00	-42.23	-36.63

- 1. Q.P. and AV. are abbreviations of quasi-peak and average individually.
- 2. The emission levels of other frequencies were very low against the limit.
- 3. Margin value = Emission level Limit value
- 4. Correction factor = Insertion loss + Cable loss
- 5. Emission Level = Correction Factor + Reading Value

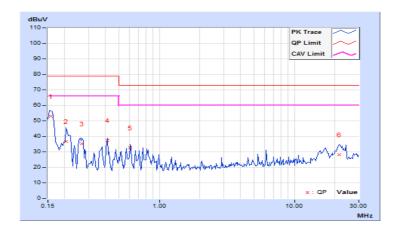




Frequency Range	150kHz ~ 30MHz	Detector Function & Bandwidth	Quasi-Peak (QP) / Average (AV), 9kHz
Input Power	110Vac, 60Hz (Adapter)	Environmental Conditions	22℃, 65%RH, 1011mbar
Tested by	Chin-Wen Wang		
Test Mode	Mode 1		

	Phase Of Power : Neutral (N)									
No	Frequency	Correction Factor	Reading Value (dBuV)		Emission Level (dBuV)		Limit (dBuV)		Margin (dB)	
	(MHz)	(dB)	Q.P.	AV.	Q.P.	AV.	Q.P.	AV.	Q.P.	AV.
1	0.15781	9.73	43.19	40.66	52.92	50.39	79.00	66.00	-26.08	-15.61
2	0.20469	9.74	26.96	19.90	36.70	29.64	79.00	66.00	-42.30	-36.36
3	0.26719	9.74	25.38	22.93	35.12	32.67	79.00	66.00	-43.88	-33.33
4	0.41172	9.74	27.64	27.21	37.38	36.95	79.00	66.00	-41.62	-29.05
5	0.60703	9.75	22.74	22.73	32.49	32.48	73.00	60.00	-40.51	-27.52
6	21.38281	10.14	17.88	10.54	28.02	20.68	73.00	60.00	-44.98	-39.32

- 1. Q.P. and AV. are abbreviations of quasi-peak and average individually.
- 2. The emission levels of other frequencies were very low against the limit.
- 3. Margin value = Emission level Limit value
- 4. Correction factor = Insertion loss + Cable loss
- 5. Emission Level = Correction Factor + Reading Value

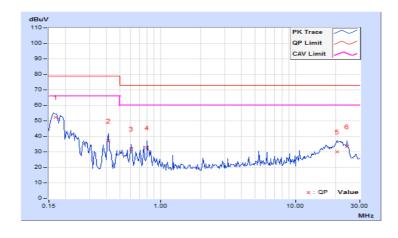




Frequency Range	150kHz ~ 30MHz		Quasi-Peak (QP) / Average (AV), 9kHz
Input Power	230Vac, 50Hz (Adapter)	Environmental Conditions	22℃, 65%RH, 1011mbar
Tested by	Chin-Wen Wang		
Test Mode	Mode 1		

	Phase Of Power : Line (L)									
No	Frequency	Correction Factor	Reading Value (dBuV)		Emission Level (dBuV)		Limit (dBuV)		Margin (dB)	
	(MHz)	(dB)	Q.P.	AV.	Q.P.	AV.	Q.P.	AV.	Q.P.	AV.
1	0.16936	9.57	42.71	36.19	52.28	45.76	79.00	66.00	-26.72	-20.24
2	0.41172	9.58	27.55	27.54	37.13	37.12	79.00	66.00	-41.87	-28.88
3	0.60703	9.59	22.16	22.01	31.75	31.60	73.00	60.00	-41.25	-28.40
4	0.80234	9.60	23.04	17.52	32.64	27.12	73.00	60.00	-40.36	-32.88
5	20.36719	9.89	20.01	12.95	29.90	22.84	73.00	60.00	-43.10	-37.16
6	24.04297	9.91	23.54	20.83	33.45	30.74	73.00	60.00	-39.55	-29.26

- 1. Q.P. and AV. are abbreviations of quasi-peak and average individually.
- 2. The emission levels of other frequencies were very low against the limit.
- 3. Margin value = Emission level Limit value
- 4. Correction factor = Insertion loss + Cable loss
- 5. Emission Level = Correction Factor + Reading Value

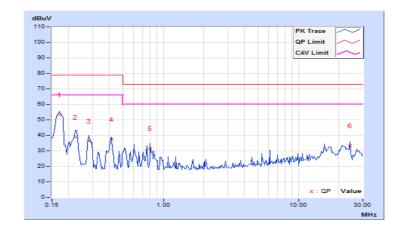




Frequency Range	150kHz ~ 30MHz	Detector Function & Bandwidth	Quasi-Peak (QP) / Average (AV), 9kHz
Input Power	230Vac, 50Hz (Adapter)	Environmental Conditions	22℃, 65%RH, 1011mbar
Tested by	Chin-Wen Wang		
Test Mode	Mode 1		

	Phase Of Power : Neutral (N)									
No	Frequency	Correction Factor		Reading Value Emission Level (dBuV)			nit uV)	Margin (dB)		
	(MHz)	(dB)	Q.P.	AV.	Q.P.	AV.	Q.P.	AV.	Q.P.	AV.
1	0.16953	9.73	43.42	39.56	53.15	49.29	79.00	66.00	-25.85	-16.71
2	0.22422	9.74	29.31	15.21	39.05	24.95	79.00	66.00	-39.95	-41.05
3	0.28281	9.74	26.53	23.08	36.27	32.82	79.00	66.00	-42.73	-33.18
4	0.41172	9.74	27.60	27.37	37.34	37.11	79.00	66.00	-41.66	-28.89
5	0.80234	9.77	21.74	16.25	31.51	26.02	73.00	60.00	-41.49	-33.98
6	24.04297	10.17	23.20	22.25	33.37	32.42	73.00	60.00	-39.63	-27.58

- 1. Q.P. and AV. are abbreviations of quasi-peak and average individually.
- 2. The emission levels of other frequencies were very low against the limit.
- 3. Margin value = Emission level Limit value
- 4. Correction factor = Insertion loss + Cable loss
- 5. Emission Level = Correction Factor + Reading Value





6 Asymmetric Mode Conducted Emission at Telecommunication Ports

6.1 Limits

For Class A Equipment

Frequency range (MHz)	Coupling device	Detector type / bandwidth	Voltage limits (dBuV)	Current limits (dBuA)
0.15 - 0.5	AAN	Quasi-peak / 9kHz	97 – 87	
0.5 - 30.0	AAN	Quasi-peak / 9ki iz	87	N/A
0.15 - 0.5	AAN	Average / OkHz	84-74	IN/A
0.5 - 30.0	AAN	Average / 9kHz	74	
0.15 - 0.5	CVP	Ougoi poek / OkUz	97 – 87	53 – 43
0.5 - 30.0	and current probe	Quasi-peak / 9kHz	87	43
0.15 - 0.5	CVP	Average / OkHz	84-74	40 – 30
0.5 - 30.0	and current probe	Average / 9kHz	74	30
0.15 - 0.5	Current Drobe	Ougoi poek / OkHz		53 – 43
0.5 - 30.0	Current Probe	Quasi-peak / 9kHz	N/A	43
0.15 - 0.5	Current Probe	Average / OkHz	IN/A	40 – 30
0.5 - 30.0	Current Probe	Average / 9kHz		30

For Class B Equipment

Frequency range (MHz)	Coupling device	Detector type / bandwidth	Voltage limits (dBuV)	Current limits (dBuA)
0.15 - 0.5	AAN	Quasi-peak / 9kHz	84 – 74	
0.5 - 30.0	AAN	Quasi-peak / 9kHz	74	N/A
0.15 - 0.5	A A N I	Average / OkHz	74-64	IN/A
0.5 - 30.0	AAN	Average / 9kHz	64	
0.15 - 0.5	CVP	Ougoi poek / OkUz	84 – 74	40 – 30
0.5 - 30.0	and current probe	Quasi-peak / 9kHz	74	30
0.15 - 0.5	CVP	Average / OkHz	74-64	30 – 20
0.5 - 30.0	and current probe	Average / 9kHz	64	20
0.15 - 0.5	Current Drobe	Ougoi poek / OkHz		40 – 30
0.5 - 30.0	Current Probe	Quasi-peak / 9kHz	NI/A	30
0.15 - 0.5	Current Probe	Avorago / OkHz	N/A	30 – 20
0.5 - 30.0	Current Probe	Average / 9kHz		20



6.2 Test Instruments

Description & Manufacturer	Model No.	Serial No.	Cal. Date	Cal. Due
ROHDE & SCHWARZ TEST RECEIVER	ESCS 30	838251/021	Nov. 1, 2017	Oct. 31, 2018
ROHDE & SCHWARZ Artificial Mains Network (For EUT)	ENV216	101195	May 2, 2017	May 1, 2018
LISN With Adapter (for EUT)	AD10	C03Ada-002	May 2, 2017	May 1, 2018
EMCO L.I.S.N. (For peripherals)	3825/2	9504-2359	Jul. 25, 2017	Jul. 24, 2018
SCHWARZBECK Artificial Mains Network (For EUT)	NNLK8129	8129229	May 9, 2017	May 8, 2018
Software	Cond_V7.3.7.4	NA	NA	NA
Software	ISN_V7.3.7.4	NA	NA	NA
RF cable (JYEBAO)	5D-FB	Cable-C03.01	Sep. 19, 2017	Sep. 18, 2018
LYNICS Terminator (For EMCO LISN)	0900510	E1-01-300	Jan. 18, 2017	Jan. 17, 2018
LYNICS Terminator (For EMCO LISN)	0900510	E1-01-301	Jan. 18, 2017	Jan. 17, 2018
FCC ISN	F-071115-1057-1	20652	Jan. 12, 2017	Jan. 11, 2018

Notes: 1. The calibration interval of the above test instruments is 12 months and the calibrations are traceable to NML/ROC and NIST/USA.

- 2. The test was performed in Shielded Room No. 3.
- 3. The VCCI Site Registration No. T-1651.
- 4. Tested Date: Dec. 11, 2017

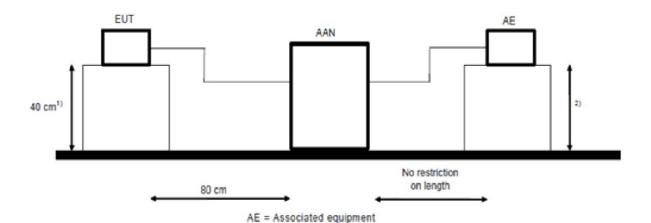


6.3 Test Arrangement

Method of Using AANs:

- a. The EUT is placed 0.4 meters from the conducting wall of the shielded room and connected to AAN directly to reference ground plane.
- b. If voltage measurement is used, measure voltage at the measurement port of the AAN, correct the reading by adding the AAN voltage division factor, and compare to the voltage limit.
- c. It is not necessary to apply the voltage and the current limit if a AAN is used.
- d. The test results of disturbance at telecommunication ports are recorded of six worst margins for quasi-peak (mandatory) [and average (if necessary)] values against the limits at frequencies of interest unless the margin is 20 dB or greater.

Note: The resolution bandwidth and video bandwidth of test receiver is 9kHz for quasi-peak detection (QP) and average detection (AV) at frequency 0.15MHz-30MHz.



- 1) Distance to the reference groundplane (vertical or horizontal).
- 2) Distance to the reference groundplane is not critical.

Note: Cable on the RGP must to be insulated.

For the actual test configuration, please refer to the related item – Photographs of the Test Configuration.

EUT = Equipment under test

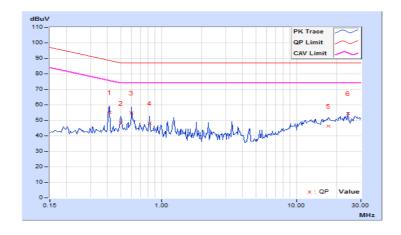


6.4 Test Results

Frequency Range	150kHz ~ 30MHz	Detector Function & Bandwidth	Quasi-Peak (QP) / Average (AV), 9kHz				
Input Power	230Vac, 50Hz (Adapter)	Environmental Conditions	21℃, 70%RH, 1011mbar				
Tested by	Chin-Wen Wang	Chin-Wen Wang					
Test Mode	Mode 1\LAN PORT 1 (1Gb	Mode 1\LAN PORT 1 (1Gbps)					

No	Frequency	Correction Factor		g Value uV)	Emissic (dB	n Level uV)		nit uV)	Maı (d	gin B)
	(MHz)	(dB)	Q.P.	AV.	Q.P.	AV.	Q.P.	AV.	Q.P.	AV.
1	0.41172	9.45	45.77	45.55	55.22	55.00	88.61	75.61	-33.39	-20.61
2	0.50547	9.40	38.89	36.81	48.29	46.21	87.00	74.00	-38.71	-27.79
3	0.60313	9.37	45.63	43.92	55.00	53.29	87.00	74.00	-32.00	-20.71
4	0.82188	9.31	38.95	38.13	48.26	47.44	87.00	74.00	-38.74	-26.56
5	17.29297	9.72	36.41	30.90	46.13	40.62	87.00	74.00	-40.87	-33.38
6	24.04297	10.11	44.37	43.48	54.48	53.59	87.00	74.00	-32.52	-20.41

- 1. Q.P. and AV. are abbreviations of quasi-peak and average individually.
- 2. The emission levels of other frequencies were very low against the limit.
- 3. Margin value = Emission level Limit value
- 4. Correction factor = Insertion loss + Cable loss
- 5. Emission Level = Correction Factor + Reading Value

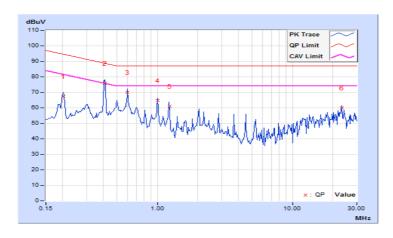




Frequency Range	150kHz ~ 30MHz	Detector Function & Bandwidth	Quasi-Peak (QP) / Average (AV), 9kHz				
Input Power	230Vac, 50Hz (Adapter)	Environmental Conditions	21℃, 70%RH, 1011mbar				
Tested by	Chin-Wen Wang	Chin-Wen Wang					
Test Mode	Mode 2\LAN PORT 2 (POE) (100Mbps)						

No	Frequency	Correction Factor		g Value uV)		n Level uV)		nit uV)	Maı (d	_
	(MHz)	(dB)	Q.P.	AV.	Q.P.	AV.	Q.P.	AV.	Q.P.	AV.
1	0.20078	9.67	57.56	57.55	67.23	67.22	94.58	81.58	-27.35	-14.36
2	0.40781	9.46	66.65	65.35	76.11	74.81	88.69	75.69	-12.58	-0.88
3	0.60313	9.37	60.65	60.64	70.02	70.01	87.00	74.00	-16.98	-3.99
4	1.00781	9.28	55.42	55.23	64.70	64.51	87.00	74.00	-22.30	-9.49
5	1.23645	9.27	51.81	51.70	61.08	60.97	87.00	74.00	-25.92	-13.03
6	23.12891	10.05	49.91	48.34	59.96	58.39	87.00	74.00	-27.04	-15.61

- 1. Q.P. and AV. are abbreviations of quasi-peak and average individually.
- 2. The emission levels of other frequencies were very low against the limit.
- 3. Margin value = Emission level Limit value
- 4. Correction factor = Insertion loss + Cable loss
- 5. Emission Level = Correction Factor + Reading Value

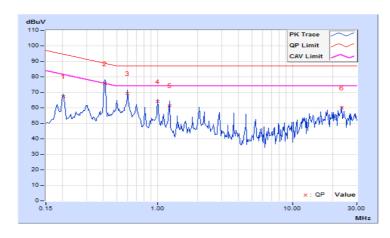




Frequency Range	150kHz ~ 30MHz	Detector Function & Bandwidth	Quasi-Peak (QP) / Average (AV), 9kHz				
Input Power	230Vac, 50Hz (Adapter)	Environmental Conditions	21℃, 70%RH, 1011mbar				
Tested by	Chin-Wen Wang	Chin-Wen Wang					
Test Mode	Mode 3\LAN PORT 3 (POE) (100Mbps)						

No	Frequency	Correction Factor		g Value uV)	Emissio (dB	n Level uV)		nit uV)	Maı (d	rgin B)
	(MHz)	(dB)	Q.P.	AV.	Q.P.	AV.	Q.P.	AV.	Q.P.	AV.
1	0.20078	9.67	57.84	57.26	67.51	66.93	94.58	81.58	-27.07	-14.65
2	0.40781	9.46	66.07	64.75	75.53	74.21	88.69	75.69	-13.16	-1.48
3	0.60313	9.37	59.75	59.74	69.12	69.11	87.00	74.00	-17.88	-4.89
4	1.00781	9.28	54.79	54.60	64.07	63.88	87.00	74.00	-22.93	-10.12
5	1.23047	9.27	52.04	52.00	61.31	61.27	87.00	74.00	-25.69	-12.73
6	23.12891	10.05	49.81	48.15	59.86	58.20	87.00	74.00	-27.14	-15.80

- 1. Q.P. and AV. are abbreviations of quasi-peak and average individually.
- 2. The emission levels of other frequencies were very low against the limit.
- 3. Margin value = Emission level Limit value
- 4. Correction factor = Insertion loss + Cable loss
- 5. Emission Level = Correction Factor + Reading Value





7 Radiated Emission at Frequencies up to 1GHz

7.1 Limits

For Class A Equipment

Frequency range (MHz)	Distance (m)	Limits (dBuV/m)
30 - 230	10	40
230 - 1000	10	47
30 - 230	2	50
230 - 1000	3	57

For Class B Equipment

Frequency range (MHz)	Distance (m)	Limits (dBuV/m)
30 - 230	10	30
230 - 1000	10	37
30 - 230	2	40
230 - 1000	3	47

7.2 Test Instruments

Description & Manufacturer	Model No.	Serial No.	Cal. Date	Cal. Due
ROHDE & SCHWARZ TEST RECEIVER	ESCI	100412	Sep. 1, 2017	Aug. 31, 2018
Schwarzbeck BILOG Antenna	VULB9168	9168-479	Dec. 16, 2016	Dec. 15, 2017
Agilent Preamplifier	8447D	2944A08312	Feb. 21, 2017	Feb. 20, 2018
CT Turn Table	TT100	CT-0055	NA	NA
CT Tower	AT100	CT-0055	NA	NA
Software	Radiated_V7.6.15.9.5	NA	NA	NA
ADT RF Switches BOX	EM-H-01-1	1002	Sep. 21 2017	Sep. 20, 2018
WOKEN RF cable With 5dB PAD	8D	CABLE-ST6-01	Sep. 21 2017	Sep. 20, 2018

Notes: 1. The calibration interval of the above test instruments is 12 months and the calibrations are traceable to NML/ROC and NIST/USA.

- 2. The test was performed in Open Site No. 6.
- 3. The VCCI Site Registration No. R-728.
- 4. Tested Date: Dec. 8, 2017

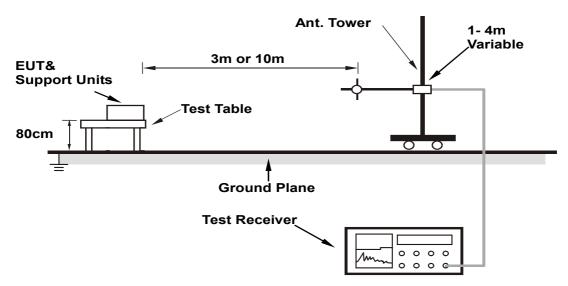


7.3 Test Arrangement

- a. The EUT was placed on the top of a rotating table 0.8 meters above the ground at an accredited test facility. The table was rotated 360 degrees to determine the position of the highest radiation.
- b. The EUT was set 10 meters away from the interference-receiving antenna, which was mounted on the top of a variable-height antenna tower.
- c. The antenna is a broadband antenna, and its height is varied from one meter to four meters above the ground to determine the maximum value of the field strength. Both horizontal and vertical polarizations of the antenna are set to make the measurement.
- d. For each suspected emission, the EUT was arranged to its worst case and then the antenna was tuned to heights from 1 meter to 4 meters and the rotatable table was turned from 0 degrees to 360 degrees to find the maximum reading.
- e. The test-receiver system was set to quasi-peak detect function and specified bandwidth with maximum hold mode when the test frequency is up to 1 GHz.

Note:

- The resolution bandwidth and video bandwidth of test receiver/spectrum analyzer is 120kHz for quasi-peak detection (QP) at frequency up to 1GHz.
- 2. The measurement distance is the shortest horizontal distance between an imaginary circular periphery just encompassing this arrangement and the calibration point of the antenna.



Note: Cable on the RGP must to be insulated.

For the actual test configuration, please refer to the related item – Photographs of the Test Configuration.

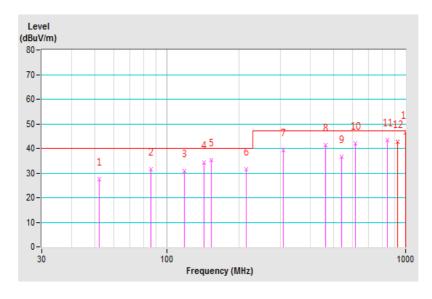


7.4 Test Results

Frequency Range	30MHz ~ 1GHz	Detector Function & Bandwidth	Quasi-Peak (QP), 120kHz
Tested by	Vhenson Huang	Environmental Conditions	15℃, 80%RH, 1010mbar
Test Mode	Mode 1		

	Antenna Polarity & Test Distance : Horizontal at 10 m								
No	Frequency (MHz)	Emission Level (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Antenna Height (m)	Table Angle (Degree)	Raw Value (dBuV)	Correction Factor (dB/m)	
1	52.23	27.47 QP	40.00	-12.53	4.00 H	109	36.87	-9.40	
2	85.72	31.52 QP	40.00	-8.48	4.00 H	169	46.24	-14.72	
3	118.45	30.74 QP	40.00	-9.26	4.00 H	82	42.24	-11.50	
4	143.06	34.09 QP	40.00	-5.91	4.00 H	24	43.20	-9.11	
5	154.14	35.40 QP	40.00	-4.60	4.00 H	199	44.03	-8.63	
6	215.90	31.62 QP	40.00	-8.38	4.00 H	185	42.83	-11.21	
7	308.23	39.38 QP	47.00	-7.62	2.96 H	166	46.28	-6.90	
8	462.45	41.27 QP	47.00	-5.73	1.92 H	193	45.25	-3.98	
9	540.00	36.74 QP	47.00	-10.26	1.66 H	208	39.62	-2.88	
10	616.61	42.07 QP	47.00	-4.93	1.37 H	16	42.59	-0.52	
11	839.26	43.53 QP	47.00	-3.47	1.00 H	150	39.96	3.57	
12	924.93	42.82 QP	47.00	-4.18	1.00 H	233	37.64	5.18	
13	999.99	46.46 QP	47.00	-0.54	1.00 H	165	40.63	5.83	

- 1. Emission Level(dBuV/m) = Raw Value(dBuV) + Correction Factor(dB/m)
- 2. Correction Factor(dB/m) = Antenna Factor (dB/m) + Cable Factor (dB)
 - Pre-Amplifier Factor (dB)
- 3. The other emission levels were very low against the limit.
- 4. Margin value = Emission level Limit value

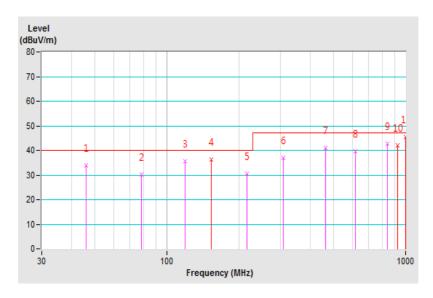




Frequency Range	30MHz ~ 1GHz	Detector Function & Bandwidth	Quasi-Peak (QP), 120kHz
Tested by	Vhenson Huang	Environmental Conditions	15℃, 80%RH, 1010mbar
Test Mode	Mode 1		

	Antenna Polarity & Test Distance : Vertical at 10 m									
No	Frequency (MHz)	Emission Level (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Antenna Height (m)	Table Angle (Degree)	Raw Value (dBuV)	Correction Factor (dB/m)		
1	45.95	33.83 QP	40.00	-6.17	1.45 V	126	43.33	-9.50		
2	78.53	30.10 QP	40.00	-9.90	1.32 V	146	43.63	-13.53		
3	119.61	35.70 QP	40.00	-4.30	1.00 V	218	47.15	-11.45		
4	154.15	36.43 QP	40.00	-3.57	1.00 V	187	45.06	-8.63		
5	216.19	30.44 QP	40.00	-9.56	1.00 V	25	41.64	-11.20		
6	308.31	36.90 QP	47.00	-10.10	1.00 V	131	43.80	-6.90		
7	462.55	40.91 QP	47.00	-6.09	1.27 V	241	44.89	-3.98		
8	616.76	39.74 QP	47.00	-7.26	2.59 V	156	40.25	-0.51		
9	839.29	42.58 QP	47.00	-4.42	2.41 V	19	39.01	3.57		
10	924.94	41.91 QP	47.00	-5.09	2.93 V	338	36.73	5.18		
11	999.99	45.36 QP	47.00	-1.64	3.23 V	192	39.53	5.83		

- 1. Emission Level(dBuV/m) = Raw Value(dBuV) + Correction Factor(dB/m)
- 2. Correction Factor(dB/m) = Antenna Factor (dB/m) + Cable Factor (dB)
 - Pre-Amplifier Factor (dB)
- 3. The other emission levels were very low against the limit.
- 4. Margin value = Emission level Limit value





8 Radiated Emission at Frequencies above 1GHz

8.1 Limits

For Class A Equipment

Frequency range (MHz)	Distance (m)	Detector type	Limits (dBuV/m)
1000 - 3000		Averege	56
3000 - 6000	2	Average	60
1000 - 3000	3	Peak	76
3000 - 6000		reak	80

For Class B Equipment

Frequency range (MHz)	Distance (m)	Detector type	Limits (dBuV/m)
1000 - 3000		Average	50
3000 - 6000	3	Average	54
1000 - 3000		Peak	70
3000 - 6000		reak	74

Required highest frequency for radiated measurement

Highest internal frequency (F _x)	Highest measured frequency		
$F_x \leq 108 \text{ MHz}$	1 GHz		
$108 \text{ MHz} < F_x \leq 500 \text{ MHz}$	2 GHz		
$500 \mathrm{MHz} < \mathrm{F_x} \le 1 \mathrm{GHz}$	5 GHz		
$F_x > 1 \text{ GHz}$	5 x F _x up to a maximum of 6 GHz		

NOTE 1 For FM and TV broadcast receivers, F_x is determined from the highest frequency generated or used excluding the local oscillator and tuned frequencies.

NOTE 2 F_x is highest fundamental frequency generated or used within the EUT or highest frequency at which it operates.

Where F_x is unknown, the radiated emission measurements shall be performed up to 6 GHz.



8.2 Test Instruments

Description & Manufacturer	Model No.	Serial No.	Cal. Date	Cal. Due
Agilent Spectrum	E4446A	MY51100009	Jun. 1, 2017	May 31, 2018
Agilent Test Receiver	N9038A	MY51210137	Jun. 23, 2017	Jun. 22, 2018
Agilent Preamplifier	8449B	3008A01292	Feb. 22, 2017	Feb. 21, 2018
MITEQ Preamplifier	AMF-6F-260400-33-8P	892164	Feb. 21, 2017	Feb. 20, 2018
EMCI Preamplifier	EMC184045B	980235	Feb. 22, 2017	Feb. 21, 2018
Schwarzbeck Horn Antenna	BBHA-9170	212	Dec. 30, 2016	Dec. 29, 2017
EMCO Horn Antenna	3115	6714	Dec. 29, 2016	Dec. 28, 2017
Max Full. Turn Table	MF7802	MF780208216	NA	NA
Software	Radiated_V8.7.08	NA	NA	NA
SUHNER RF cable With 3/4dB PAD	SF102	Cable-CH10-3.6m	Aug. 14, 2017	Aug. 13, 2018
MICRO-TRONICS Notch filter	BRC50703-01	010	May 31, 2017	May 30, 2018
MICRO-TRONICS Band Pass Filter	BRM17690	005	May 31, 2017	May 30, 2018

Notes: 1. The calibration interval of the above test instruments is 12 months and the calibrations are traceable to NML/ROC and NIST/USA.

- 2. The 3dB beamwidth of the horn antenna is minimum 30 degree (or w = 1.6m at 3m distance) for $1\sim6$ GHz.
- 3. The test was performed in Chamber No. 10.
- 4. The Industry Canada Reference No. IC 7450E-11.
- 5. The VCCI Site Registration No. G-10427
- 6. Tested Date: Dec. 11, 2017

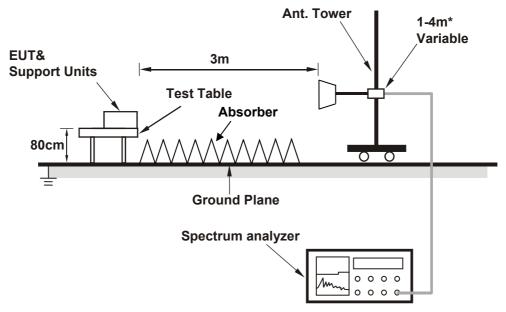


8.3 Test Arrangement

- a. The EUT was placed on the top of a rotating table 0.8 meters above the ground at an accredited chamber room. The table was rotated 360 degrees to determine the position of the highest radiation.
- b. The EUT was set 3 meters away from the interference-receiving antenna, which was mounted on the top of a variable-height antenna tower.
- c. The height of antenna can be varied from one meter to four meters, the height of adjustment depends on the EUT height and the antenna 3dB beamwidth both, to detect the maximum value of the field strength. Both horizontal and vertical polarizations of the antenna are set to make the measurement.
- d. For each suspected emission, the EUT was arranged to its worst case and then the antenna was tuned to heights and the rotatable table was turned from 0 degrees to 360 degrees to find the maximum reading.
- e. The spectrum analyzer system was set to peak and average detect function and specified bandwidth with maximum hold mode when the test frequency is above 1 GHz.

Note:

- 1. The resolution bandwidth of test receiver/spectrum analyzer is 1MHz and video bandwidth is 3MHz for Peak detection (PK) at frequency above 1GHz. The resolution bandwidth of test receiver/spectrum analyzer is 1 MHz for Average detection (AV) at frequency above 1GHz.
- 2. The measurement distance is the shortest horizontal distance between an imaginary circular periphery just encompassing this arrangement and the calibration point of the antenna.



Note: Cable on the RGP must to be insulated.

For the actual test configuration, please refer to the related item – Photographs of the Test Configuration.

^{*:} depends on the EUT height and the antenna 3dB beamwidth both.

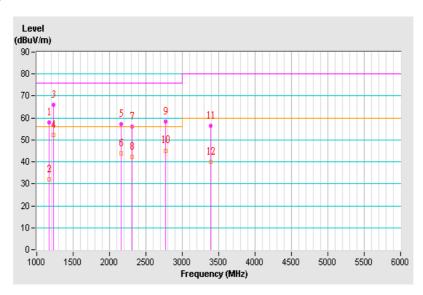


8.4 Test Results

Frequency Range	1GHz ~ 6GHz	Detector Function & Bandwidth	Peak (PK) / Average (AV), 1MHz
Tested by	ED.Lin	Environmental Conditions	20℃, 70%RH, 1011mbar
Test Mode	Mode 1		

	Antenna Polarity & Test Distance : Horizontal at 3 m									
No	Frequency (MHz)	Emission Level (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Antenna Height (m)	Table Angle (Degree)	Raw Value (dBuV)	Correction Factor (dB/m)		
1	1171.58	58.07 PK	76.00	-17.93	2.15 H	325	63.30	-5.23		
2	1171.58	31.94 AV	56.00	-24.06	2.15 H	325	37.17	-5.23		
3	1233.25	65.80 PK	76.00	-10.20	1.60 H	202	70.89	-5.09		
4	1233.25	52.26 AV	56.00	-3.74	1.60 H	202	57.35	-5.09		
5	2155.97	57.34 PK	76.00	-18.66	1.50 H	184	59.33	-1.99		
6	2155.97	43.73 AV	56.00	-12.27	1.50 H	184	45.72	-1.99		
7	2310.06	56.18 PK	76.00	-19.82	1.92 H	323	57.75	-1.57		
8	2310.06	42.29 AV	56.00	-13.71	1.92 H	323	43.86	-1.57		
9	2774.76	58.38 PK	76.00	-17.62	1.96 H	176	58.32	0.06		
10	2774.76	45.15 AV	56.00	-10.85	1.96 H	176	45.09	0.06		
11	3391.39	56.27 PK	80.00	-23.73	1.00 H	178	54.53	1.74		
12	3391.39	40.05 AV	60.00	-19.95	1.00 H	178	38.31	1.74		

- 1. Emission Level(dBuV/m) = Raw Value(dBuV) + Correction Factor(dB/m)
- 2. Correction Factor(dB/m) = Antenna Factor (dB/m) + Cable Factor (dB)
 - Pre-Amplifier Factor (dB)
- 3. The other emission levels were very low against the limit.
- 4. Margin value = Emission level Limit value

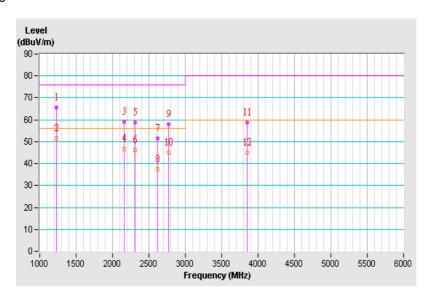




Frequency Range	1GHz ~ 6GHz	Detector Function & Bandwidth	Peak (PK) / Average (AV), 1MHz
Tested by	ED.Lin	Environmental Conditions	20℃, 70%RH, 1011mbar
Test Mode	Mode 1		

Antenna Polarity & Test Distance : Vertical at 3 m											
No	Frequency (MHz)	Emission Level (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Antenna Height (m)	Table Angle (Degree)	Raw Value (dBuV)	Correction Factor (dB/m)			
1	1233.25	65.50 PK	76.00	-10.50	1.46 V	194	70.59	-5.09			
2	1233.25	51.37 AV	56.00	-4.63	1.46 V	194	56.46	-5.09			
3	2155.99	59.19 PK	76.00	-16.81	1.98 V	168	61.18	-1.99			
4	2155.99	46.70 AV	56.00	-9.30	1.98 V	168	48.69	-1.99			
5	2310.02	58.71 PK	76.00	-17.29	1.98 V	197	60.28	-1.57			
6	2310.02	46.20 AV	56.00	-9.80	1.98 V	197	47.77	-1.57			
7	2620.68	51.42 PK	76.00	-24.58	2.04 V	360	51.96	-0.54			
8	2620.68	37.41 AV	56.00	-18.59	2.04 V	360	37.95	-0.54			
9	2774.78	58.03 PK	76.00	-17.97	2.51 V	153	57.97	0.06			
10	2774.78	44.88 AV	56.00	-11.12	2.51 V	153	44.82	0.06			
11	3853.87	58.79 PK	80.00	-21.21	2.45 V	226	55.16	3.63			
12	3853.87	44.85 AV	60.00	-15.15	2.45 V	226	41.22	3.63			

- 1. Emission Level(dBuV/m) = Raw Value(dBuV) + Correction Factor(dB/m)
- 2. Correction Factor(dB/m) = Antenna Factor (dB/m) + Cable Factor (dB)
 - Pre-Amplifier Factor (dB)
- 3. The other emission levels were very low against the limit.
- 4. Margin value = Emission level Limit value





9 Harmonics Current Measurement

9.1 Limits

Limits for Class A equipment			Limits for Class D equi	pment
Harmonic Order	Max. permissible harmonics current	Harmonic Order	Max. permissible harmonics current per	Max. permissible harmonics current
n	Α	n	watt mA/W	A
0	odd harmonics		Odd Harmonics on	У
3	2.30	3	3.4	2.30
5	1.14	5	1.9	1.14
7	0.77	7	1.0	0.77
9	0.40	9	0.5	0.40
11	0.33	11	0.35	0.33
13	0.21	13	0.30	0.21
15≦n≦39	0.15 x 15/n	15≦n≦39	3.85/n	0.15 x 15/n
E	ven harmonics			
2	1.08			
4	0.43			
6	0.30			
8≦n≦40	0.23 x 8/n			

Notes: 1. Class A and Class D are classified according to section 5 of EN 61000-3-2.

2. According to section 7 of EN 61000-3-2, the above limits for all equipment except for lighting equipment having an active input power > 75 W and no limits apply for equipment with an active input power up to and including 75 W.

9.2 Classification of Equipment

Class A	Class B	Class C	Class D
Balanced three-phase equipment;	Portable tools;	Lighting	Equipment having a specified
Household appliances excluding	Arc welding	equipment.	power less than or equal to 600
equipment as Class D;	equipment which is		W of the following types:
Tools excluding portable tools;	not professional		Personal computers and
Dimmers for incandescent lamps;	equipment.		personal computer monitors;
Audio equipment;			Television receivers;
Equipment not specified in one of the			Refrigerators and freezers
three other classes.			having one or more
			variable-speed drives to control
			compressor motor(s).



9.3 Test Instruments

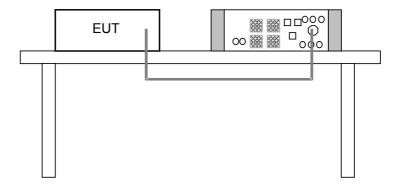
Description & Manufacturer	Model No.	Serial No.	Cal. Date	Cal. Due
Teseq Harmonics - Flicker Test System	Profline 2105	32A00983 & 1639A01863	Sep. 28, 2017	Sep. 27, 2018
Software	WIN2100	NA	NA	NA

Notes: 1. The calibration interval of the above test instruments is 12 months and the calibrations are traceable to NML/ROC and NIST/USA.

- 2. The test was performed in EMS Room No. 1.
- 3. According to IEC 61000-4-7: 2002, the time window shall be synchronized with each group of 10 or 12 cycles (200 ms)for power frequency of 50 or 60Hz.
- 4. Tested Date: Dec. 15, 2017.

9.4 Test Arrangement

- a. The EUT was placed on the top of a wooden table 0.8 meters above the ground and operated to produce the maximum harmonic components under normal operating conditions for each successive harmonic component in turn.
- b. The correspondent test program of test instrument to measure the current harmonics emanated from EUT is chosen. The measure time shall be not less than the time necessary for the EUT to be exercised.



For the actual test configuration, please refer to the related item – Photographs of the Test Configuration.



9.5 Test Results

	229.98Vrms/ 0.284Arms	Power Frequency	50.00Hz
Power Consumption	48.3W	Power Factor	0.751
Environmental Conditions	24 °C, 62%RH	Tested by	Chiming Li
Test Mode	Mode 1		

Note:

- 1. Limits are not specified for equipment with a rated power of 75W or less (other than lighting equipment).
- 2. According to EN 61000-3-2 the manufacturer shall specify the power of the apparatus. This value shall be used for establishing limits. The specified power shall be within +/-10% of the measured power.



10 Voltage Fluctuations and Flicker Measurement

10.1 Limits

Test item	Limit	Note
P_{st}	1.0	P _{st:} short-term flicker severity.
P _{lt}	0.65	P _{lt:} long-term flicker severity.
T _{max} (ms)	500	T _{max:} maximum time duration during the observation period that the voltage deviation d(t) exceeds the limit for d _c .
d _{max} (%)	4	d _{max:} maximum absolute voltage change during an observation period.
d _c (%)	3.3	d _{c:} maximum steady state voltage change during an observation period.

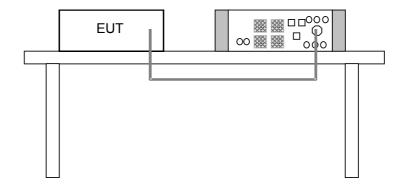
10.2 Test Instruments

Description & Manufacturer	Model No.	Serial No.	Cal. Date	Cal. Due
Teseq Harmonics - Flicker Test System	Profline 2105	32A00983 & 1639A01863	Sep. 28, 2017	Sep. 27, 2018
Software	WIN2100	NA	NA	NA

- Notes: 1. The calibration interval of the above test instruments is 12 months and the calibrations are traceable to NML/ROC and NIST/USA.
 - 2. The test was performed in EMS Room No. 1.
 - 3. Tested Date: Dec. 15, 2017.

10.3 Test Arrangement

- a. The EUT was placed on the top of a wooden table 0.8 meters above the ground and operated to produce the most unfavorable sequence of voltage changes under normal operating conditions.
- b. During the flick measurement, the measure time shall include that part of whole operation cycle in which the EUT produce the most unfavorable sequence of voltage changes. The observation period for short-term flicker indicator is 10 minutes and the observation period for long-term flicker indicator is 2 hours.



For the actual test configuration, please refer to the related item – Photographs of the Test Configuration.

Report No.: CE171206D25 Page No. 40 / 79 Report Format Version: 6.1.3



10.4 Test Results

	229.98Vrms/ 0.284Arms	Power Frequency	50.00Hz
Observation (T _p)	10 min.	Power Factor	0.751
Environmental Conditions	24 °C, 62%RH	Tested by	Chiming Li
Test Mode	Mode 1		

Test Parameter	Measurement Value	Limit	Remarks
P_{st}	0.064	1.00	Pass
P _{lt}	0.028	0.65	Pass
T _{max} (ms)	0	500	Pass
d _{max} (%)	0	4	Pass
d _c (%)	0	3.3	Pass

Note: (1) P_{st} means short-term flicker indicator.

- (2) P_{It} means short-term flicker indicator.
 (3) T_{max} means accumulated time value of d(t) with a deviation exceeding 3.3 %.
 (4) d_{max} means maximum relative voltage change.
 (5) d_c means maximum relative steady-state voltage change.



11 General Immunity Requirements

EN 5502	EN 55024:2010, Immunity requirements					
Clause	Reference standard	Table	Test specification	Performance Criterion		
4.2.1	EN/IEC 61000-4-2 ESD	1.3	Enclosure port: ±8kV Air discharge, ±4kV Contact discharge	В		
4.2.3.2	EN/IEC 61000-4-3 RS	1.2	Enclosure port: 80-1000 MHz, 3V/m, 80% AM (1kHz)	Α		
4.2.2	EN/IEC 61000-4-4	2.3	Signal ports and telecommunication ports: xDSL equipment: ±0.5kV, 5/50 (T _r /T _h) ns, 100kHz others: ±0.5kV, 5/50 (T _r /T _h) ns, 5kHz	В		
	EFT	3.3	Input DC power port: ±0.5kV, 5/50 (T _r /T _h) ns, 5kHz			
		4.5	Input AC Power ports: ±1kV, 5/50 (T _r /T _h) ns, 5kHz			
		2.2	Signal and telecommunication ports (direct to outdoor cables): 10/700 (5/320) (T _r /T _h) µs w/o primary protectors: ±1kV, or with primary protectors fitted: ±4kV	С		
4.2.5	4.2.5 EN/IEC 61000-4-5 Surge		Input DC power port (direct to outdoor cables): 1.2/50 (8/20) (T _r /T _h) µs Line to earth: ±0.5kV	В		
		4.4	Input AC Power ports: 1.2/50 (8/20) (T _r /T _h) μs, Line to line: ±1kV Line to earth: ±2kV	D		
		2.1	Signal and telecommunication ports(cable length > 3m): 0.15-80 MHz, 3V, 80% AM (1kHz)			
4.2.3.3	EN/IEC 61000-4-6 CS	3.1	Input DC power port: 0.15-80 MHz, 3V, 80% AM (1kHz)	Α		
		4.1	Input AC Power ports: 0.15-80 MHz, 3V, 80% AM (1kHz)			
4.2.4	EN/IEC 61000-4-8 PFMF	1.1	Enclosure port: 50 or 60 Hz, 1A/m	А		
EN/IEC 61000-4-11 Dips & Interruptions		4.2	Input AC Power ports: Voltage Dips: >95% reduction – 0.5 period 30% reduction – 25 periods	B C		
		4.3	Input AC Power ports: Voltage Interruptions: >95% reduction – 250 periods	С		



11.1 Performance Criteria

General Performance Criteria

Performance criterion A

The equipment shall continue to operate as intended without operator intervention. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer when the equipment is used as intended. The performance level may be replaced by a permissible loss of performance. If the minimum performance level or the permissible performance loss is not specified by the manufacturer, then either of these may be derived from the product description and documentation, and by what the user may reasonably expect from the equipment if used as intended.

Performance criterion B

After the test, the equipment shall continue to operate as intended without operator intervention. No degradation of performance or loss of function is allowed, after the application of the phenomena below a performance level specified by the manufacturer, when the equipment is used as intended. The performance level may be replaced by a permissible loss of performance. During the test, degradation of performance is allowed. However, no change of operating state or stored data is allowed to persist after the test. If the minimum performance level (or the permissible performance loss) is not specified by the manufacturer, then either of these may be derived from the product description and documentation, and by what the user may reasonably expect from the equipment if used as intended.

Performance criterion C

Loss of function is allowed, provided the function is self-recoverable, or can be restored by the operation of the controls by the user in accordance with the manufacturer's instructions. Functions, and/or information stored in non-volatile memory, or protected by a battery backup, shall not be lost.

Particular performance criteria

The particular performance criteria which are specified in the normative annexes of EN 55024 take precedence over the corresponding parts of the general performance criteria. Where particular performance criteria for specific functions are not given, then the general performance criteria shall apply.



12 Electrostatic Discharge Immunity Test (ESD)

12.1 Test Specification

Basic Standard: EN/IEC 61000-4-2 **Discharge Impedance:** 330 ohm / 150 pF

Discharge Voltage: Air Discharge: ±2, ±4, ±8kV (Direct)

Contact Discharge: ±2, ±4kV (Direct/Indirect)

Number of Discharge: Air – Direct: 10 discharges per location (each polarity)

Contact - Direct & Indirect: 25 discharges per location (each polarity) and

min. 200 times in total

Discharge Mode: Single Discharge Discharge Period: 1-second minimum

12.2 Test Instruments

Description & Manufacturer	Model No.	Serial No.	Cal. Date	Cal. Due
KeyTek, ESD Simulator	MZ-15/EC	1203252	Sep. 22, 2017	Sep. 21, 2018

Notes: 1. The calibration interval of the above test instruments is 12 months and the calibrations are traceable to NML/ROC and NIST/USA.

2. The test was performed in ESD Room No. 2.

3. Tested Date: Jan. 4, 2018

12.3 Test Arrangement

The discharges shall be applied in two ways:

a. Contact discharges to the conductive surfaces and coupling planes:

The EUT shall be exposed to at least 200 discharges, 100 each at negative and positive polarity, at a minimum of four test points. One of the test points shall be subjected to at least 50 indirect discharges to the center of the front edge of the horizontal coupling plane. The remaining three test points shall each receive at least 50 direct contact discharges. If no direct contact test points are available, then at least 200 indirect discharges shall be applied in the indirect mode. Test shall be performed at a maximum repetition rate of one discharge per second.

b. Air discharges at slots and apertures and insulating surfaces:

On those parts of the EUT where it is not possible to perform contact discharge testing, the equipment should be investigated to identify user accessible points where breakdown may occur. Such points are tested using the air discharge method. This investigation should be restricted to those area normally handled by the user. A minimum of 10 single air discharges shall be applied to the selected test point for each such area.



The basic test procedure was in accordance with EN/IEC 61000-4-2:

- a. Electrostatic discharges were applied only to those points and surfaces of the EUT that are accessible to users during normal operation.
- b. The test was performed with at least ten single discharges on the pre-selected points in the most sensitive polarity.
- c. The time interval between two successive single discharges was at least 1 second.
- d. The ESD generator was held perpendicularly to the surface to which the discharge was applied and the return cable was at least 0.2 meters from the EUT.
- e. Contact discharges were applied to the non-insulating coating, with the pointed tip of the generator penetrating the coating and contacting the conducting substrate.
- f. Air discharges were applied with the round discharge tip of the discharge electrode approaching the EUT as fast as possible (without causing mechanical damage) to touch the EUT. After each discharge, the ESD generator was removed from the EUT and re-triggered for a new single discharge. The test was repeated until all discharges were complete.
- g. At least ten single discharges (in the most sensitive polarity) were applied to the Horizontal Coupling Plane at points on each side of the EUT. The ESD generator was positioned at a distance of 0.1 meters from the EUT with the discharge electrode touching the HCP.
- h. At least ten single discharges (in the most sensitive polarity) were applied to the center of one vertical edge of the **V**ertical **C**oupling **P**lane in sufficiently different positions that the four faces of the EUT were completely illuminated. The **VCP** (dimensions 0.5m x 0.5m) was placed vertically to and 0.1 meters from the EUT.

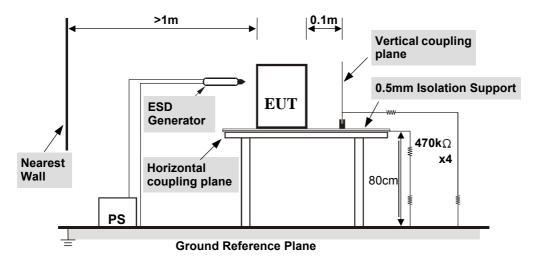


TABLE-TOP EQUIPMENT

The configuration consisted of a wooden table 0.8 meters high standing on the **G**round **R**eference **P**lane. The **GRP** consisted of a sheet of aluminum at least 0.25mm thick, and 2.5 meters square connected to the protective grounding system. A **H**orizontal **C**oupling **P**lane (1.6m x 0.8m) was placed on the table and attached to the **GRP** by means of a cable with $940k\Omega$ total impedance. The equipment under test, was installed in a representative system as described in section 7 of

EN/IEC 61000-4-2, and its cables were placed on the **HCP** and isolated by an insulating support of 0.5mm thickness. A distance of 1-meter minimum was provided between the EUT and the walls of the laboratory and any other metallic structure.

For the actual test configuration, please refer to the related item – Photographs of the Test Configuration.



12.4 Test Results

Input Power	230 Vac, 50 Hz	Tested by	Chiming Li
Environmental Conditions	23 °C, 51% RH 1010 mbar	Test mode	Mode 1

	Test Results of Direct Application						
Discharge Level (kV)	Polarity (+/-)	Test Point	Contact Discharge	Air Discharge	Performance Criterion		
2	+/-	1-2	Note 1	NA	Α		
4	+/-	1-2	Note 2	NA	В		
2, 4	+/-	3-13	NA	Note 1	Α		
8	+/-	13	NA	Note 1	Α		
8	+/-	3-12	NA	Note 2	В		

Description of test points of direct application: Please refer to following page for representative mark only.

Test Results of Indirect Application							
Discharge Polarity Level (kV) (+/-) Test Point		Horizontal Coupling Plane	Vertical Coupling Performance Plane Criterion				
2, 4	+/- Four Sides		Note 1	Note 1	Α		

Description of test points of indirect application:

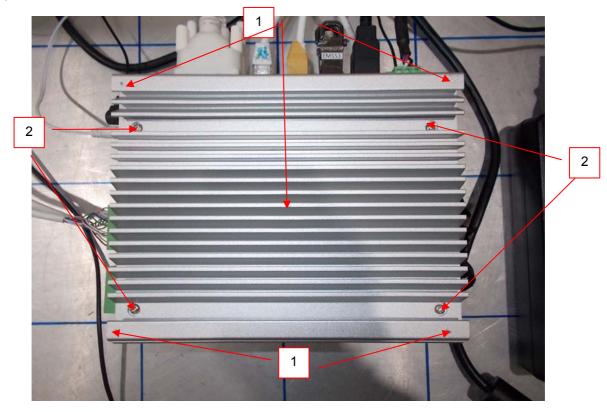
- 1. Front side
- 2. Rear side
- 3. Right side
- 4. Left side

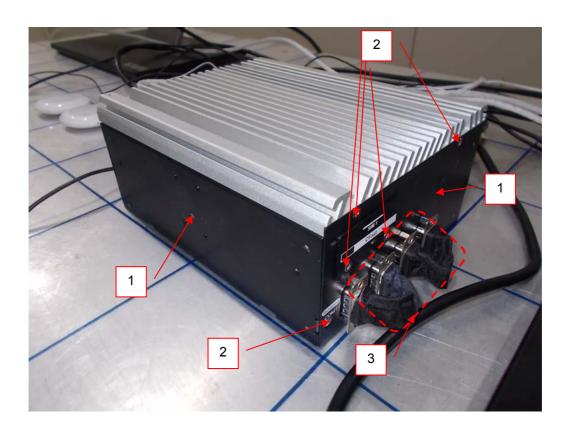
Note: 1. The EUT function was correct during the test.

2. There was horizontal bar on the screen during the test, but self-recoverable after the test.

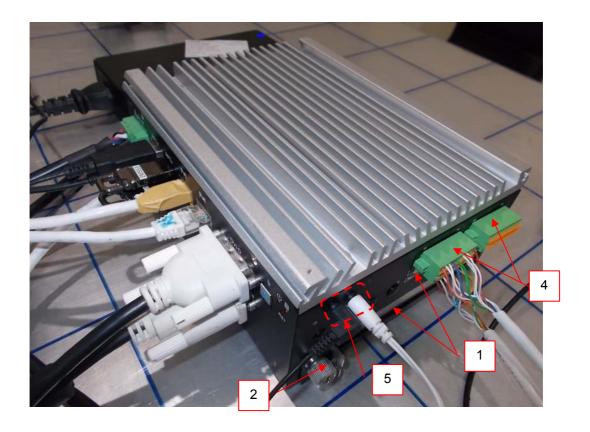


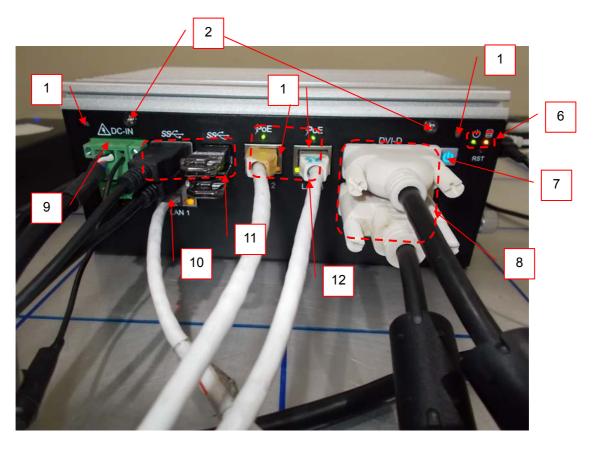
Description of Test Points

















13 Radiated, Radio-frequency, Electromagnetic Field Immunity Test (RS)

13.1 Test Specification

Basic Standard: EN/IEC 61000-4-3 Frequency Range: 80 MHz - 1000 MHz

Field Strength: 3 V/m

Modulation: 1kHz Sine Wave, 80%, AM Modulation Frequency Step: 1 % of preceding frequency value

Polarity of Antenna: Horizontal and Vertical

Antenna Height: 1.5m

Dwell Time: 3 seconds

13.2 Test Instruments

Description & Manufacturer	Model No.	Serial No.	Cal. Date	Cal. Due
Agilent Signal Generator	E8257D	MY48050465	Jun. 3, 2017	Jun. 2, 2018
PRANA RF Amplifier	AP32DP280	0811-894	NA	NA
TESEQ RF Amplifier	CBA1G-150	T44220	NA	NA
AR RF Amplifier	35S4G8AM4	0326094	NA	NA
AR RF Amplifier	100S1G4M3	0329249	NA	NA
AR Controller	SC1000M3	305910	NA	NA
Narda Broadband Field Meter	NBM-550	B-0872	Feb. 9, 2016	Feb. 8, 2018
BOONTON RF Voltage Meter	4232A	10180	May 19, 2017	May 18, 2018
BOONTON Power Sensor	51013-4E	34870	Jun. 2, 2017	Jun. 1, 2018
BOONTON Power Sensor	51013-4E	34873	Jun. 2, 2017	Jun. 1, 2018
AR Log-Periodic Antenna	AT6080	0329465	NA	NA
EMCO BiconiLog Antenna	3141	1001	NA	NA
AR High Gain Antenna	AT4002A	306533	NA	NA
AR High Gain Horn Antenna	AT4010	0329800	NA	NA
CHANCE MOST Full Anechoic Chamber (9x5x3m)	Chance Most	RS-002	Feb. 6, 2017	Feb. 5, 2018
Software	RS_V7.6	NA	NA	NA

Notes: 1. The calibration interval of the above test instruments is 12/24 months and the calibrations are traceable to NML/ROC and NIST/USA.

- 2. The test was performed in RS Room No.2.
- 3. Tested Date: Jan. 3, 2018



13.3 Test Arrangement

The test procedure was in accordance with EN/IEC 61000-4-3.

- a. The testing was performed in a modified semi-anechoic chamber.
- b. The frequency range is swept from 80 MHz to 1000 MHz, with the signal 80% amplitude modulated with a 1kHz sine wave.
- c. The field strength level was 3 V/m.
- d. The test was performed with the EUT exposed to both vertically and horizontally polarized fields on each of the four sides.

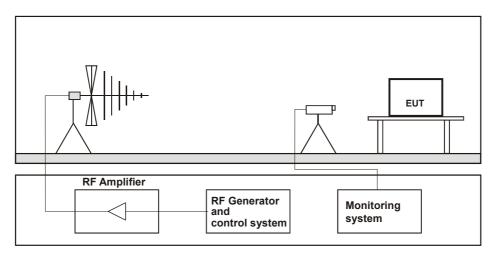


Table-top Equipment

The EUT installed in a representative system as described in section 7 of EN/IEC 61000-4-3 was placed on a non-conductive table 0.8 meters in height. The system under test was connected to the power and signal wire according to relevant installation instructions.

For the actual test configuration, please refer to the related item – Photographs of the Test Configuration.



13.4 Test Results

Input Power	230 Vac, 50 Hz	Tested by	Chiming Li
Environmental Conditions	22 °C, 67% RH	Test mode	Mode 1

Fraguency (MHz)	Fraguency (MHz) Polarity		MHz) Polarity Azimuth(°)		Applied	d Field Strength	Observation	Performance
Frequency (MHz)	Polarity	Azimum ()	(V/m)	Modulation	Observation	Criterion		
80 -1000	V&H	0	3	80% AM (1kHz)	Note	Α		
80 -1000	V&H	90	3	80% AM (1kHz)	Note	Α		
80 -1000	V&H	180	3	80% AM (1kHz)	Note	Α		
80 -1000	V&H	270	3	80% AM (1kHz)	Note	Α		

Note: The EUT function was correct during the test.

Remark: LAN 1 use shielded LAN



14 Electrical Fast Transient/Burst Immunity Test (EFT)

14.1 Test Specification

Basic Standard: EN/IEC 61000-4-4

Test Voltage: Signal / telecommunication port: ±0.5kV

Input DC power port: N/A Input AC power port: ±1kV

Impulse Repetition Frequency: xDSL telecommunication port: 100kHz

others: 5kHz

Impulse Wave Shape: 5/50 ns

Burst Duration: 0.75 ms for 100kHz Repetition Frequency

15 ms for 5kHz Repetition Frequency

Burst Period: 300 ms Test Duration: 1 min.

14.2 Test Instruments

Description & Manufacturer	Model No.	Serial No.	Cal. Date	Cal. Due
Haefely, EFT Generator	PEFT 4010	154954	Apr. 17, 2017	Apr. 16, 2018
Haefely, Capacitive Clamp	IP4A	155173	Apr. 17, 2017	Apr. 16, 2018

Notes: 1. The calibration interval of the above test instruments is 12 months and the calibrations are traceable to NML/ROC and NIST/USA.

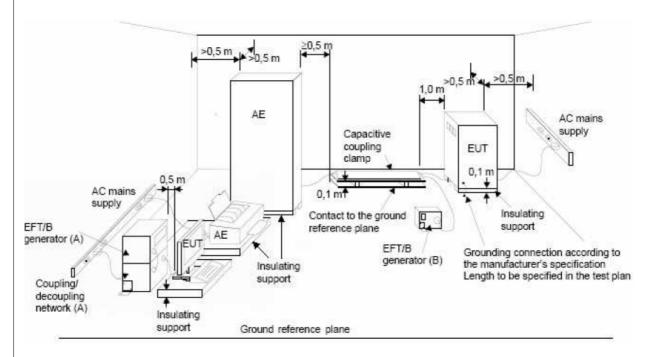
2. The test was performed in EFT Room.

3. Tested Date: Jan. 2, 2018



14.3 Test Arrangement

- a. Both positive and negative polarity discharges were applied.
- b. The distance between any coupling devices and the EUT should be 0.5 m for table-top equipment testing, and 1.0 m for floor standing equipment.
- c. The duration time of each test sequential was 1 minute.
- d. The transient/burst waveform was in accordance with EN/IEC 61000-4-4, 5/50 ns.



NOTE:

- (A) location for supply line coupling
- (B) location for signal lines coupling

For the actual test configuration, please refer to the related item – Photographs of the Test Configuration.



14.4 Test Results

Input Power	230 Vac, 50 Hz	Tested by	Chiming Li
Environmental Conditions	22 °C, 65% RH	Test mode	Mode 1

Input AC power port

Voltage (kV)	Test Point	Polarity (+/-)	Observation	Performance Criterion
1	L1	+/-	Note	Α
1	L2	+/-	Note	Α
1	PE	+/-	Note	Α
1	L1-L2-PE	+/-	Note	Α

Signal / telecommunication port

Voltage (kV)	Test Point	Polarity (+/-)	Observation	Performance Criterion
0.5	LAN 1	+/-	Note	Α
0.5	PoE LAN 2	+/-	Note	Α
0.5	PoE LAN 3	+/-	Note	Α

Note: The EUT function was correct during the test.



15 Surge Immunity Test

15.1 Test Specification

Basic Standard: EN/IEC 61000-4-5

Wave-Shape: Signal / telecommunication port (direct to outdoor cables*):

10/700 μs Open Circuit Voltage 5/320 μs Short Circuit Current

Input DC power port (direct to outdoor cables*):

1.2/50 µs Open Circuit Voltage 8/20 µs Short Circuit Current

Input AC power port:

1.2/50 μs Open Circuit Voltage 8/20 μs Short Circuit Current

Test Voltage: Signal and telecommunication ports**:

w/o primary protectors: N/A with primary protectors fitted: N/A

Input DC power port:

Line to earth or ground: N/A

Input AC power ports: Line to line: ±0.5kV, ±1kV

Line to earth or ground: ±0.5kV, ±1kV, ±2kV

AC Phase Angle (degree): 0°, 90°, 180°, 270° Pulse Repetition Rate: 1 time / 20 sec.

Number of Tests: 5 positive and 5 negative at selected points

- * This test is only applicable only to ports, which according to the manufacturer's specification, may connect directly to outdoor cables.
- ** For ports where primary protection is intended, surges are applied at voltages up to 4 kV with the primary protectors fitted. Otherwise the 1 kV test level is applied without primary protection in place.

15.2 Test Instruments

Description & Manufacturer	Model No.	Serial No.	Cal. Date	Cal. Due
TESEQ, Surge Simulator	NSG 3060	1572	May 23, 2017	May 22, 2018
Coupling Decoupling Network	CDN-UTP8	028	Aug. 18, 2017	Aug. 17, 2018
TESEQ Coupling Decoupling Network	CDN HSS-2	41009	May 19, 2017	May 18, 2018
TESEQ Coupling Decoupling Networ	CDN 118-T8	40386	Sep. 14, 2017	Sep. 13, 2018
TESEQ CDN for Unshielded Unsymmetrical Signal & Data Lines	CDN117	40144	Sep. 14, 2017	Sep. 13, 2018

Notes: 1. The calibration interval of the above test instruments is 12 months and the calibrations are traceable to NML/ROC and NIST/USA.

- 2. The test was performed in EMS Room No. 2.
- 3. Tested Date: Jan. 4, 2018



15.3 Test Arrangement

a. Input AC/DC Power ports:

The surge is to be applied to the EUT power supply terminals via the capacitive coupling network. Decoupling networks are required in order to avoid possible adverse effects on equipment not under test that may be powered by the same lines, and to provide sufficient decoupling impedance to the surge wave. The power cord between the EUT and the coupling/decoupling networks shall be 2 meters in length (or shorter).

For double-insulated products without PE or external earth connections, the test shall be done in a similar way as for grounded products but without adding any additional external grounded connections. If there are no other possible connections to earth, line-to-ground tests may be omitted.

- b. Signal and telecommunication ports,
 - Unshielded unsymmetrical interconnection lines:

The surge is applied to the lines via the capacitive coupling. The coupling / decoupling networks shall not influence the specified functional conditions of the EUT. The interconnection line between the EUT and the coupling/decoupling networks shall be 2 meters in length.

Unshielded symmetrical interconnections communication lines:

The surge is applied to the lines via gas arrestors coupling. Test levels below the ignition point of the coupling arrestor cannot be specified. The interconnection line between the EUT and the coupling/decoupling networks shall be 2 meters in length.

High speed communications lines

Prior to the test, the correct operation of the port shall be verified; the external connection shall then be removed and the surge applied directly to the port's terminals with no coupling /decoupling network. After the surge, the correct operation of the port shall again be verified.

- Shielded lines:
 - Direct application,

The EUT is isolated from ground and the surge is applied to its metallic enclosure; the termination (or auxiliary equipment) at the port(s) under test is grounded. This test applies to equipment with single or multiple shielded cables.

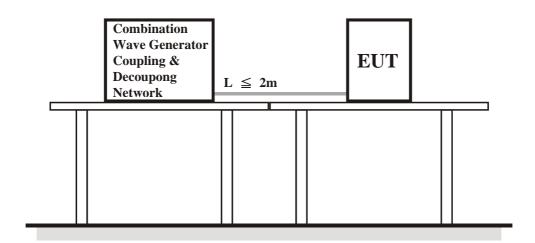
Rules for application of the surge to shielded lines:

- a) Shields grounded at both ends
 - The surge injection on the shield.
- b) Shields grounded at one end
 - If in the installation the shield is connected only at the auxiliary equipment, test shall be done in that configuration but with the generator still connected to the EUT side. If cable lengths allow, the cables shall be on insulated supports 0,1 m above the ground plane or cable tray.

For products which do not have metallic enclosures, the surge is applied directly to the shielded cable.

- Alternative coupling method for testing single cables in a multi-shield configuration, Surges are applied in close proximity to the interconnection cable under test by a wire. The length of the cable between the port(s) under test and the device attached to the other end of the cable shall be the lesser of: the maximum length permitted by the EUT's specification, or 20 m. Where the length exceeds 1 m, excess lengths of cables shall be bundled at the approximate centre of the cables with the bundles 30 cm to 40 cm in length.





For the actual test configuration, please refer to the related item – Photographs of the Test Configuration.

15.4 Test Results

Input Power	230 Vac, 50 Hz	Tested by	Chiming Li
Environmental Conditions	23 °C, 67% RH	Test mode	Mode 1

Input AC power port

mpatric perior peri						
Voltage (kV)	ge (kV) Test Point Polarity (+/-) Observation		Observation	Performance Criterion		
0.5, 1	L1-L2	+/-	Note 1	Α		
0.5, 1, 2	L1-PE	+/-	Note 2	В		
0.5, 1, 2	L2-PE	+/-	Note 2	В		

Note: 1. The EUT function was correct during the test.

2. There were horizontal bars on the screen during the test, but self-recover after the test.



16 Immunity to Conducted Disturbances Induced by RF Fields (CS)

16.1 Test Specification

Basic Standard: EN/IEC 61000-4-6 Frequency Range: 0.15 MHz - 80 MHz

Voltage Level: 3 V

Modulation: 1kHz Sine Wave, 80%, AM Modulation Frequency Step: 1 % of preceding frequency value

Dwell Time 3 seconds



16.2 Test Instruments

Description & Manufacturer	Model No.	Serial No.	Cal. Date	Cal. Due
ROHDE & SCHWARZ Signal Generator	SML03	101801	Jan. 6, 2017	Jan. 5, 2018
Digital Sweep Function Generator	8120	984801	NA	NA
AR Power Amplifier	75A250AM1	306331	NA	NA
FCC Coupling Decoupling Network	FCC-801-M2-16A	01047	Jun. 21, 2017	Jun. 20, 2018
FISCHER CUSTOM COMMUNICATIONS EM Injection Clamp	F-203I-23mm	455	NA	NA
FISCHER CUSTOM COMMUNICATIONS Current Injection Clamp	F-120-9A	361	Jul. 26, 2017	Jul. 25, 2018
B&K Ear Simulator	4185	2553594	NA	NA
EM TEST Coupling Decoupling Network	CDN M1/32A	306508	Jun. 21, 2017	Jun. 20, 2018
TESEQ Coupling Decoupling Network	CDN T800	34428	Jun. 21, 2017	Jun. 20, 2018
FCC Coupling Decoupling Network	FCC-801-T4	02031	Jun. 21, 2017	Jun. 20, 2018
EM TEST Coupling Decoupling Network	CDN T2	306509	Jun. 21, 2017	Jun. 20, 2018
R&S Power Sensor	NRV-Z5	837878/039	Oct. 30, 2017	Oct. 29, 2018
R&S Power Meter	NRVD	837794/040	Oct. 30, 2017	Oct. 29, 2018
TESEQ Coupling Decoupling Network	CDN M232	37702	Jun. 21, 2017	Jun. 20, 2018
TESEQ Coupling Decoupling Network	CDN M332	41258	Jun. 21, 2017	Jun. 20, 2018
TESEQ Coupling Decoupling Network	CDN M332	41256	Jun. 21, 2017	Jun. 20, 2018
TESEQ Coupling Decoupling Network	CDN T400A	28569	Jun. 21, 2017	Jun. 20, 2018
TESEQ Coupling Decoupling Network	CDN T8-10	40376	Jun. 21, 2017	Jun. 20, 2018
Software	CS_V7.4.2	NA	NA	NA

Notes: 1. The calibration interval of the above test instruments is 12 months and the calibrations are traceable to NML/ROC and NIST/USA.

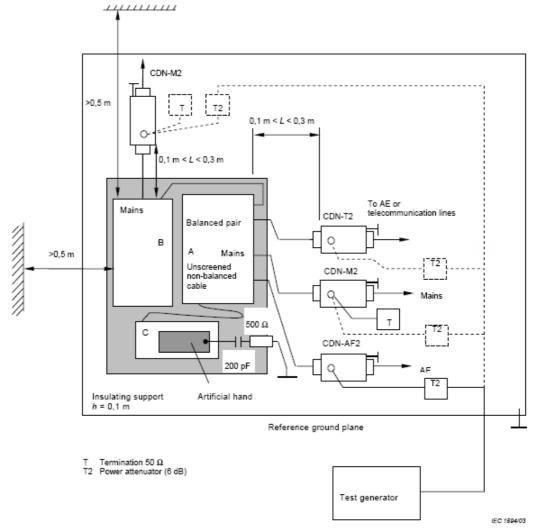
2. The test was performed in CS Room No. 1.

3. Tested Date: Jan. 2, 2018



16.3 Test Arrangement

- a. The EUT shall be tested within its intended operating and climatic conditions.
- b. An artificial hand was placed on the hand-held accessory and connected to the ground reference plane.
- c. One of the CDNs not used for injection was terminated with 50 ohm, providing only one return path. All other CDNs were coupled as decoupling networks.
- d. The frequency range is swept from 150 kHz to 80 MHz, using the signal level established during the setting process and with a disturbance signal of 80 % amplitude. The signal is modulated with a 1 kHz sine wave, pausing to adjust the RF signal level or the switch coupling devices as necessary. Where the frequency is swept incrementally, the step size shall not exceed 1 % of the preceding frequency value.
- e. Attempts should be made to fully exercise the EUT during testing, and to fully interrogate all exercise modes selected for susceptibility.



Note: 1.The EUT clearance from any metallic obstacles shall be at least 0,5 m.

- 2. Interconnecting cables (≤1 m) belonging to the EUT shall remain on the insulating support.
- 3. The equipment to be tested is placed on an insulating support of 0.1 meters height above a ground reference plane. All relevant cables shall be provided with the appropriate coupling and decoupling devices at a distance between 0.1 meters and 0.3 meters from the projected geometry of the EUT on the ground reference plane.

For the actual test configuration, please refer to the related item – Photographs of the Test Configuration.



16.4 Test Results

Input Power	230 Vac, 50 Hz	Tested by	Chiming Li
Environmental Conditions	23 °C, 66% RH	Test mode	Mode 1

Frequency (MHz)	Level (Vrms)	Tested Line	Injection Method	Return Path	Observation	Performance Criterion
0.15 – 80	3	AC Power	CDN-M3	CDN-T8	Note	Α
0.15 - 80	3	STP LAN 1	EM Clamp	CDN-M3	Note	Α
0.15 - 80	3	PoE LAN 2	CDN-T8	CDN-M3	Note	Α
0.15 – 80	3	PoE LAN 3	CDN-T8	CDN-M3	Note	Α

Note: The EUT function was correct during the test.



17 Power Frequency Magnetic Field Immunity Test

17.1 Test Specification

Basic Standard: EN/IEC 61000-4-8

Frequency Range: 50Hz
Field Strength: 1 A/m
Observation Time: 1 minute

Inductance Coil: Rectangular type, 1 m x 1 m

17.2 Test Instruments

Description & Manufacturer	Model No.	Serial No.	Cal. Date	Cal. Due
HAEFELY Magnetic Field Tester	MAG 100	083794-06	NA	NA
COMBINOVA Magnetic Field Meter	MFM10	224	Apr. 17, 2017	Apr, 16, 2018

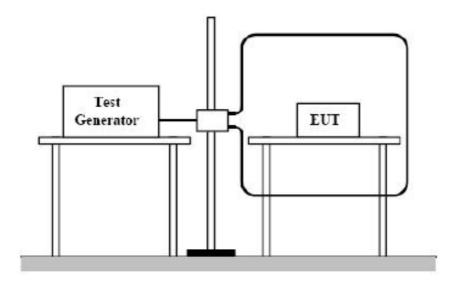
Notes: 1. The calibration interval of the above test instruments is 12 months and the calibrations are traceable to NML/ROC and NIST/USA.

2. The test was performed in EMS Room No. 1

3. Tested Date: Dec. 15, 2017

17.3 Test Arrangement

- a. The equipment is configured and connected to satisfy its functional requirements.
- b. The power supply, input and output circuits shall be connected to the sources of power supply, control and signal.
- c. The cables supplied or recommended by the equipment manufacturer shall be used. 1 meter of all cables used shall be exposed to the magnetic field.



TABLETOP EQUIPMENT

The equipment shall be subjected to the test magnetic field by using the induction coil of standard dimension (1 m x 1 m). The induction coil shall then be rotated by 90 degrees in order to expose the EUT to the test field with different orientations.

For the actual test configuration, please refer to the related item – Photographs of the Test Configuration.



17.4 Test Results

Input Power	230 Vac, 50 Hz	Tested by	Chiming Li
Environmental Conditions	21 °C, 69% RH	Test mode	Mode 1

Application	Frequency (Hz)	Field Strength (A/m)	Observation	Performance Criterion
X - Axis	50	1	Note	Α
Y - Axis	50	1	Note	Α
Z - Axis	50	1	Note	Α

Note: The EUT function was correct during the test.



18 Voltage Dips and Interruptions

18.1 Test Specification

Basic Standard: EN/IEC 61000-4-11

Test levels: Voltage Dips:

>95% reduction – 0.5 period 30% reduction – 25 periods

Voltage Interruptions:

>95% reduction – 250 periods

Interval between Event: Minimum ten seconds

Sync Angle (degrees): 0° / 180° Test Cycle: 3 times

18.2 Test Instruments

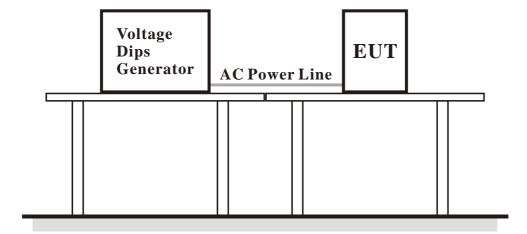
Description & Manufacturer	Model No.	Serial No.	Cal. Date	Cal. Due
Teseq Immunity Test System	Profline 2105	1632A00983 & 1639A01863	Sep. 28, 2017	Sep. 27, 2018
Software	WIN2120	NA	NA	NA

Notes: 1. The calibration interval of the above test instruments is 12 months and the calibrations are traceable to NML/ROC and NIST/USA.

- 2. The test was performed in EMS Room No. 1.
- 3. Tested Date: Dec. 15, 2017

18.3 Test Arrangement

The EUT shall be tested for each selected combination of test levels and duration with a sequence of 3 dips/interruptions with intervals of 10 s minimum (between each test event). Each representative mode of operation shall be tested. Abrupt changes in supply voltage shall occur at 0 dregee crossover point of the voltage waveform.



For the actual test configuration, please refer to the related item – Photographs of the Test Configuration.



18.4 Test Results

Test mode	Mode 1	Input Power	230 Vac, 50 Hz/ 240 Vac, 50 Hz/ 100 Vac, 50 Hz
Enviromental conditions	21 °C, 69% RH	Tested by	Chiming Li

Input Power for testing: 230 Vac, 50 Hz (Nominal input Voltage)						
Voltage Reduction	Duration	Interval (sec) Times Observation Perform				
(%)	(period)	interval (sec)		Observation	Criterion	
>95	0.5	10	3	Note 1	Α	
30	25	10	3	Note 1	Α	
>95	250	10	3	Note 2	С	

l.	Input Power for testing: 240 Vac, 50 Hz (Maximum rated input voltage)							
Voltage Reduction (%) Duration (period) Interval (sec) Times Observation Performance Criterion								
>95	0.5	10	3	Note 1	Α			
30	25	10	3	Note 1	Α			
>95	250	10	3	Note 2	С			

Input Power for testing: 100 Vac, 50 Hz (Minimum rated input voltage)							
Voltage Reduction Duration (%) Interval (sec) Times Observation Performance Criterion							
>95	0.5	10	3	Note 1	Α		
30	25	10	3	Note 1	Α		
>95	250	10	3	Note 2	С		

Note: 1. The EUT function was correct during the test.
2. The EUT shut down, but could be restored by the operator.



19 Pictures of Test Arrangements

19.1 Conducted Emission from the AC Mains Power Port



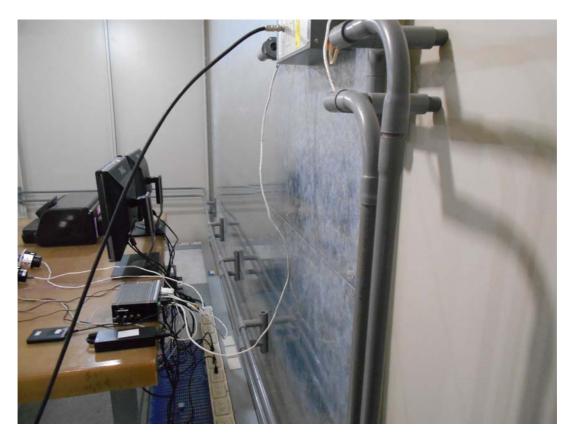




19.2 Asymmetric Mode Conducted Emission at Telecommunication Ports

LAN Port 1















19.3 Radiated Emission at Frequencies up to 1GHz

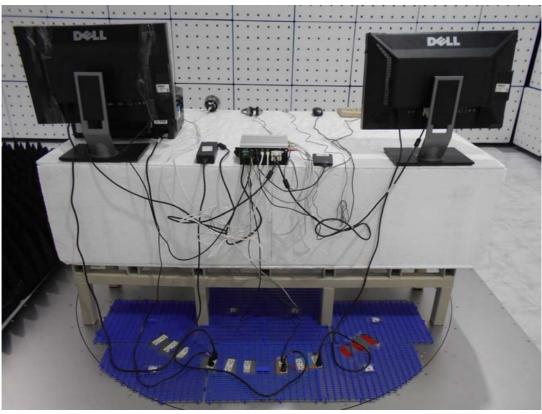






19.4 Radiated Emission at Frequencies above 1GHz







19.5 Harmonics Current, Voltage Fluctuations and Flicker Measurement



19.6 Electrostatic Discharge Immunity Test (ESD)





19.7 Radio-frequency, Electromagnetic Field Immunity Test (RS)







19.8 Electrical Fast Transient/Burst Immunity Test (EFT)

Mains ports



LAN











19.9 Surge Immunity Test

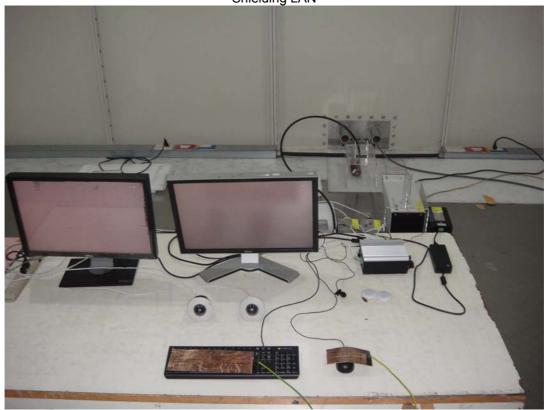


19.10 Conducted Disturbances Induced by RF Fields (CS)







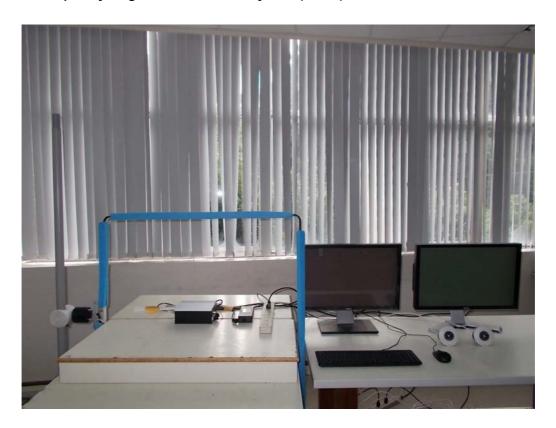


PoE LAN

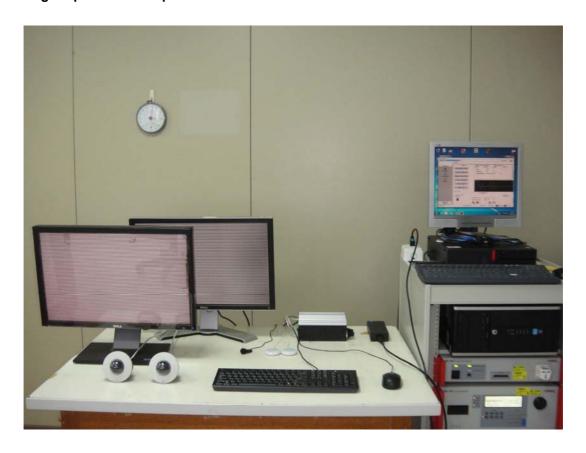




19.11 Power Frequency Magnetic Field Immunity Test (PFMF)



19.12 Voltage Dips and Interruptions





Appendix - Information on the Testing Laboratories

We, Bureau Veritas Consumer Products Services (H.K.) Ltd., Taoyuan Branch, were founded in 1988 to provide our best service in EMC, Radio, Telecom and Safety consultation. Our laboratories are accredited and approved according to ISO/IEC 17025.

If you have any comments, please feel free to contact us at the following:

Linko EMC/RF Lab

Hsin Chu EMC/RF/Telecom Lab Tel: 886-2-26052180 Tel: 886-3-6668565 Fax: 886-2-26051924 Fax: 886-3-6668323

Hwa Ya EMC/RF/Safety Lab

Tel: 886-3-3183232 Fax: 886-3-3270892

Email: service.adt@tw.bureauveritas.com Web Site: www.bureauveritas-adt.com

The address and road map of all our labs can be found in our web site also.

--- END ---